

Magnet Coil

Design, Construction, Quench Protection and Test Results

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Superconducting Magnet Division
November 30, 2011

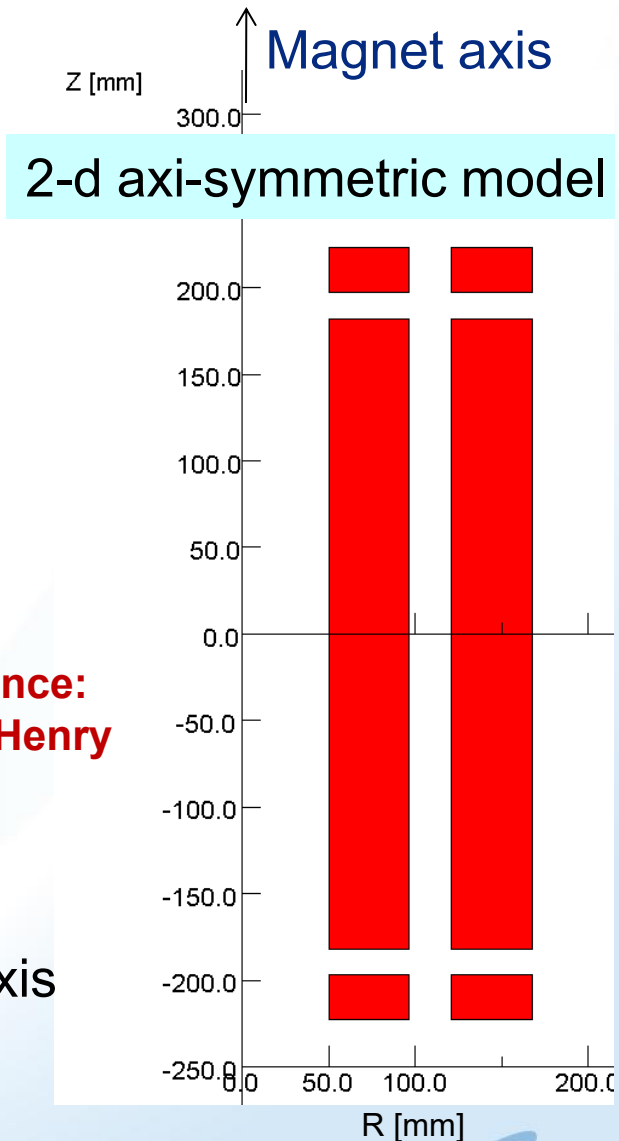
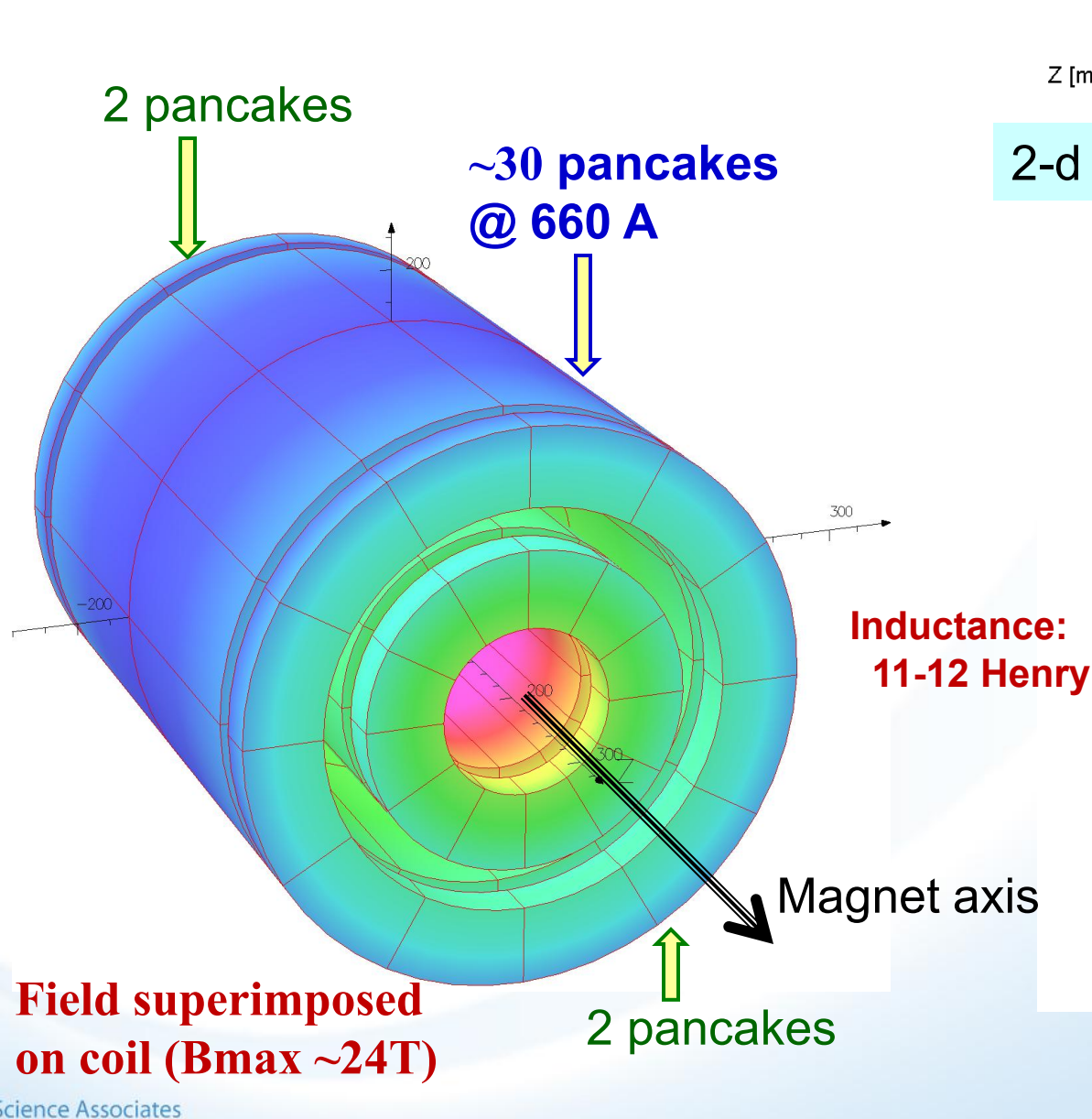


Overview

- **Progress in the Design**
- **Construction and Test Results**
 - Significant part of this presentation
- **Design Studies and Possible Feedback**
- **Quench Protection**
 - Including measurements
- **Status of Milestones & Major Accomplishments**
- **Summary**

Progress in Design

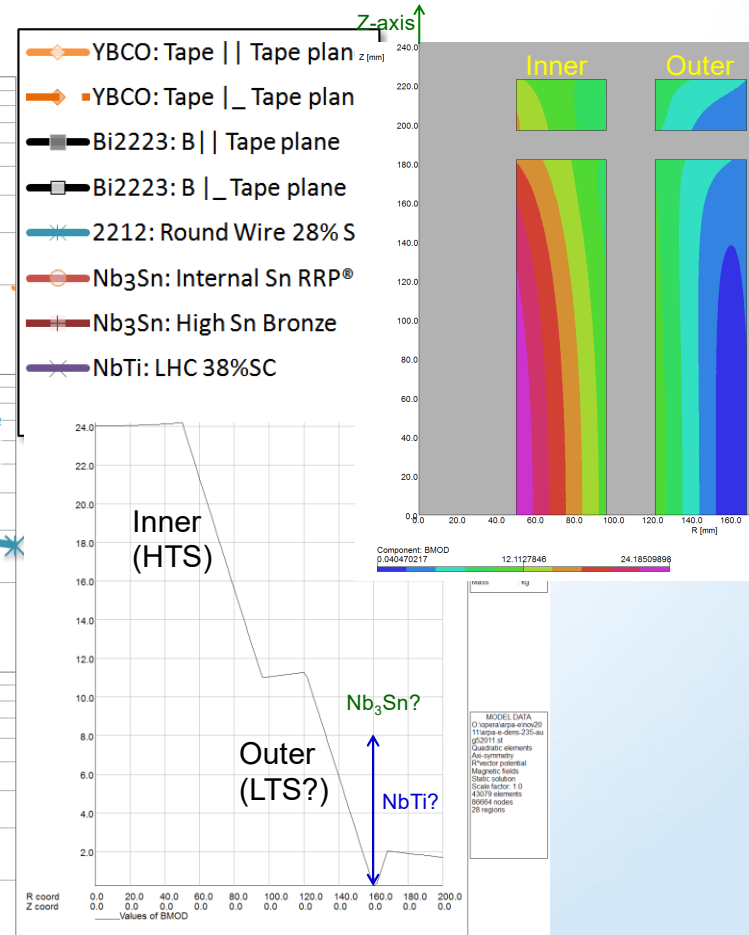
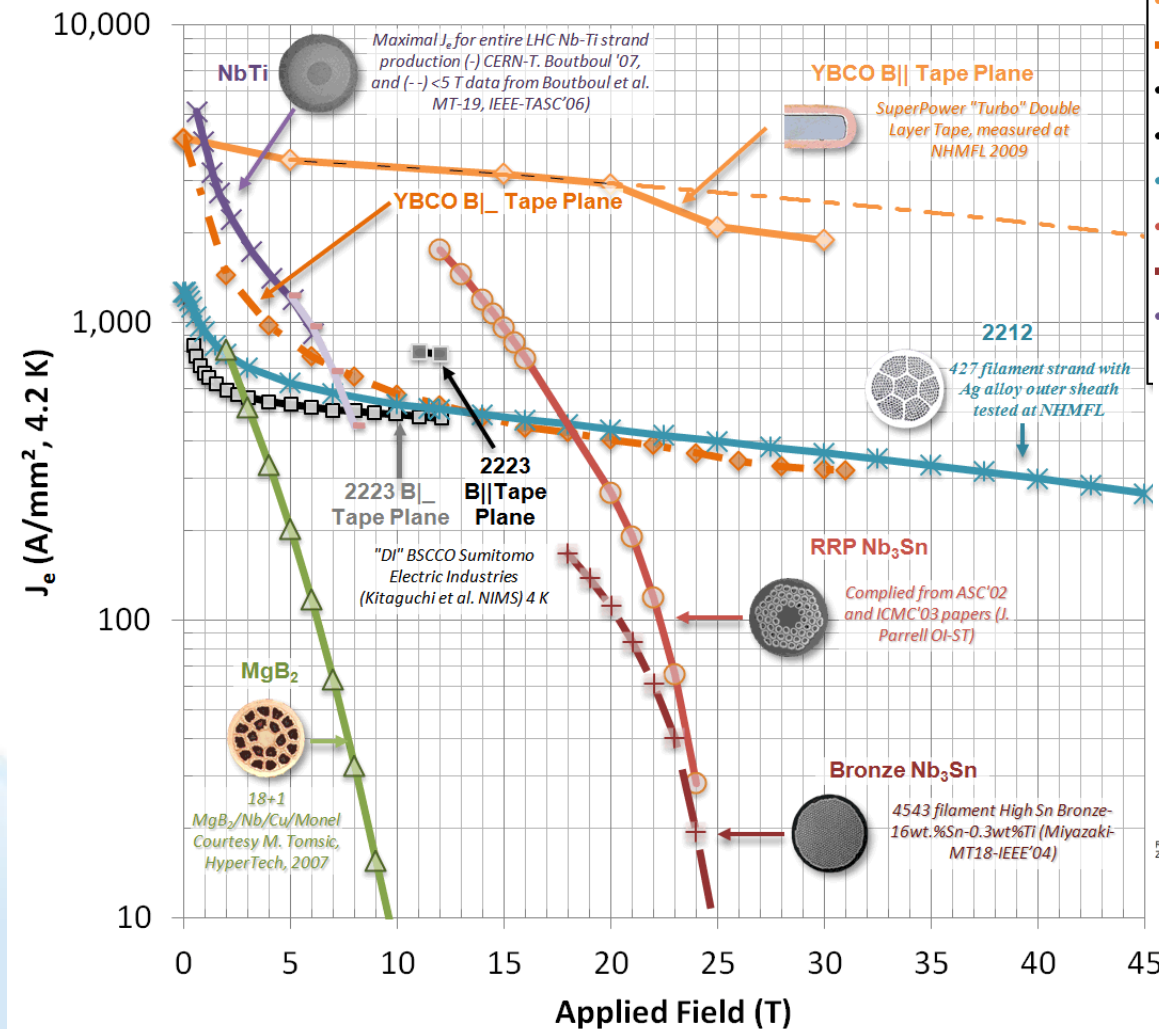
Basic Magnetic Design of 2.5 MJ Demo Coil



Magnetic Design Optimization

Spacers to reduce perpendicular component and stresses

Current Density Across Entire Cross-Section

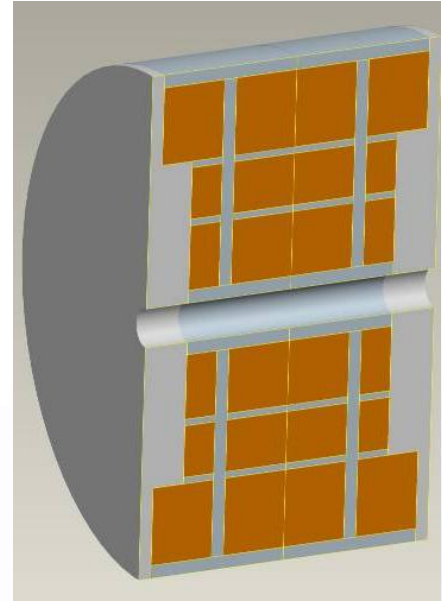
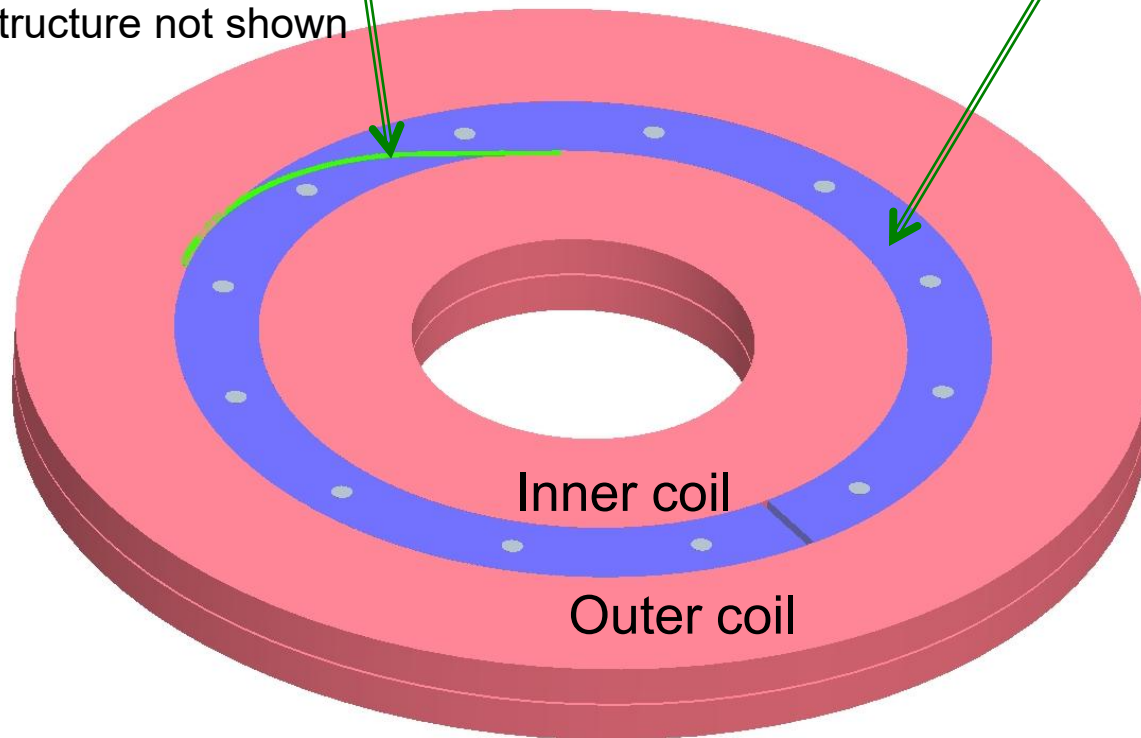


Mechanical Structure Consisting of Double Pancakes (with internal support structure)

Splice between
inner and outer

Internal support structure
(split in two parts)

External support
structure not shown



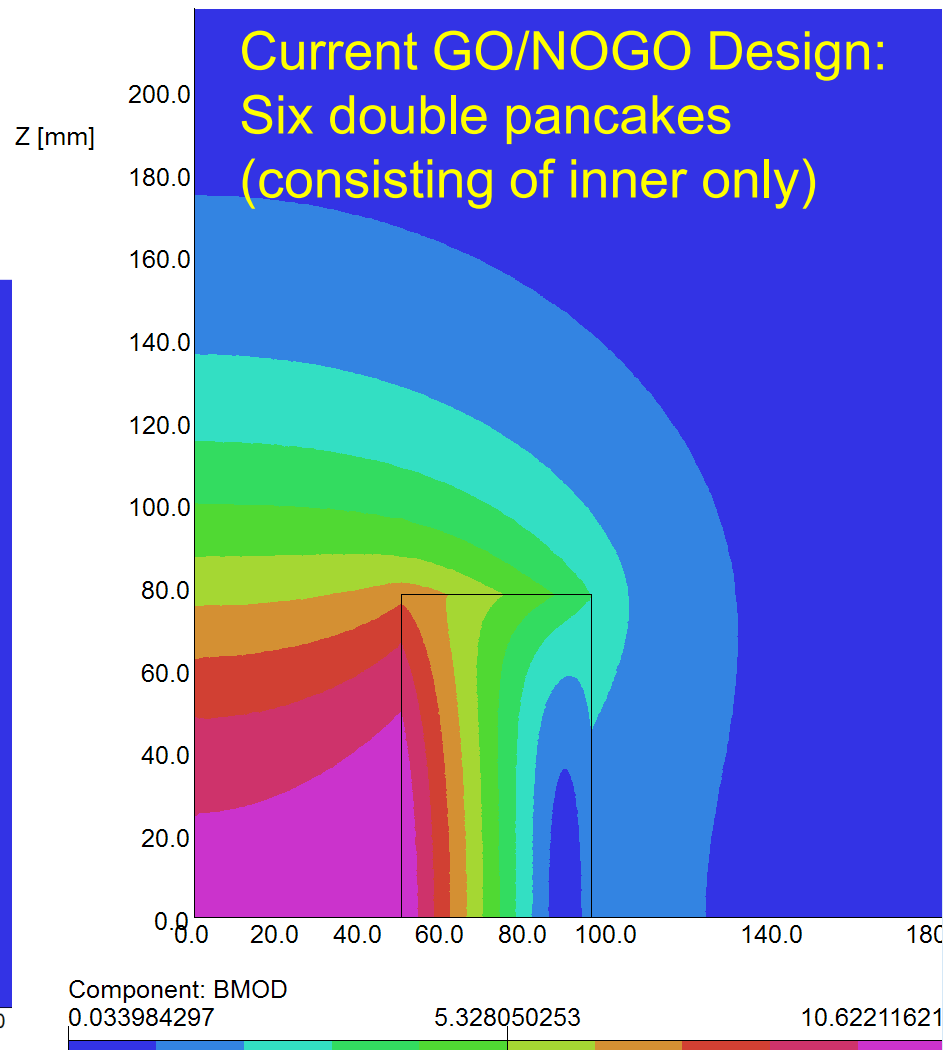
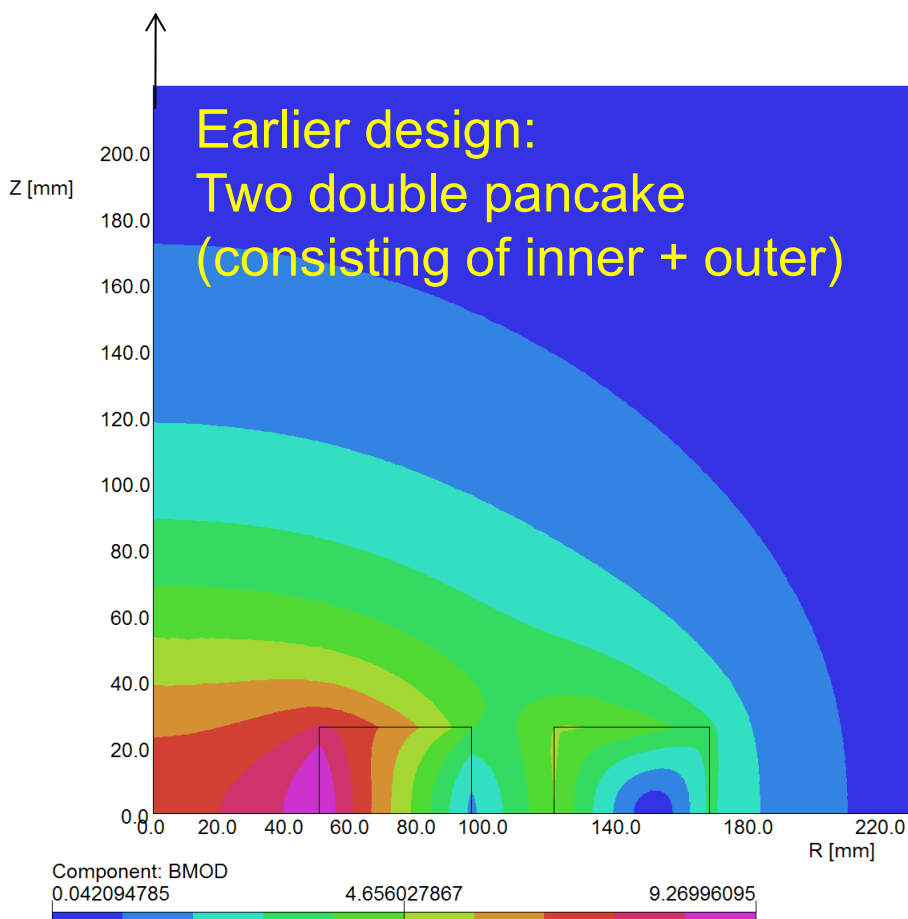
This design requires
significant analysis and
engineering before we can
proceed with construction

Current (new) design is a two coils (inner and outer) each consisting of a number of pancakes. We can proceed with inner coil construction now.

Design of Q6 GO/NO GO Test

Part of the Q6 outer coil

Magnet axis



Construction and Test Results

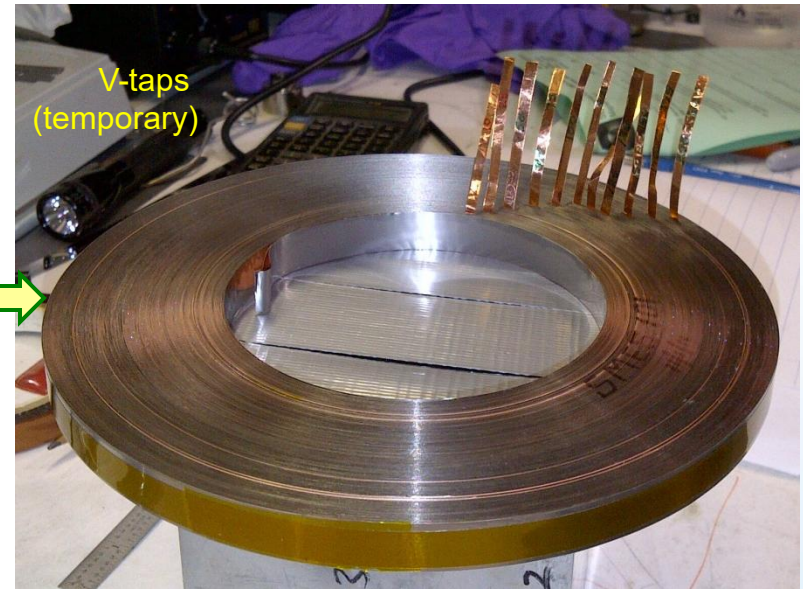
Q4 GO/NOGO Milestone

- We take the motivation behind GO/NOGO milestone (*Successful test of a mini stack of coils at 77 K*) seriously
- “Successful Test” means demonstration (not design) to show that the magnet division has most if not all technologies ready before starting the full construction
- Critical components of mini coil stack technology:
 - Demonstration winding and other tooling with real coils
 - Demonstration of splice joints (within coil and between coils)
 - Demonstration of the capability of test facility
 - Demonstration of the basic quench protection system

New Coils Wound with Improved Winder



HTS
Coil



HTS Coil
(Full Size)



SS Coil
(Full Size)

Step 1 for Making Stack of Coils: Joints

➤ Joints are one of the most critical component of the magnet. Magnet performance is often limited because of the joints.

For expediency, we carefully apply the technology in use in SMD.

Necessary steps:

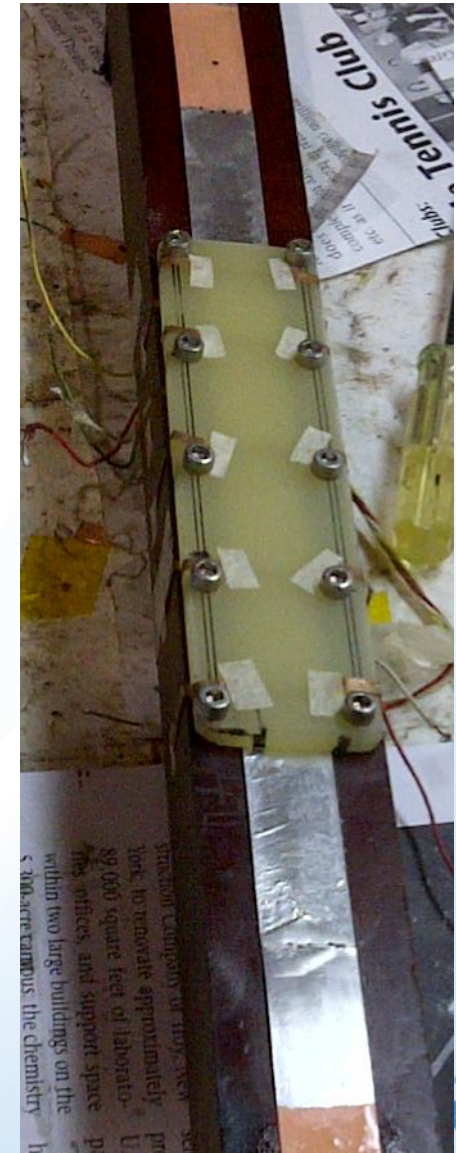
1. Finalize geometry for both joints (in coil and between coils)
2. Either (a) make “in coil” joint straight and bend them in coil or (b) make them bent while winding; (a) preferred if degradation is small
3. Check reproducibility
4. Most joint tests are performed at 77K. Determine 77K to 4K scaling
5. Prove mechanical robustness in a real coil test

Note: Above work is not part of the R&D for joint milestone. That is being carried out by AEM & will be incorporated later in the coil.

Two Types of Splices

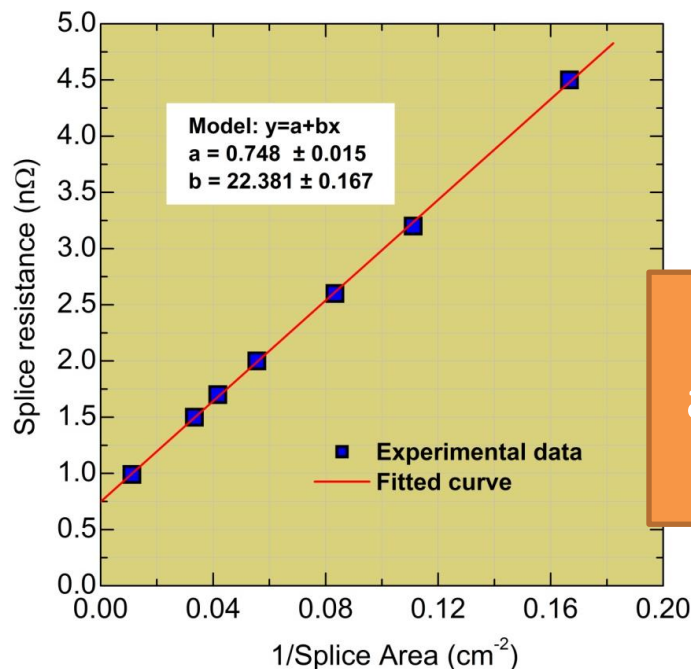
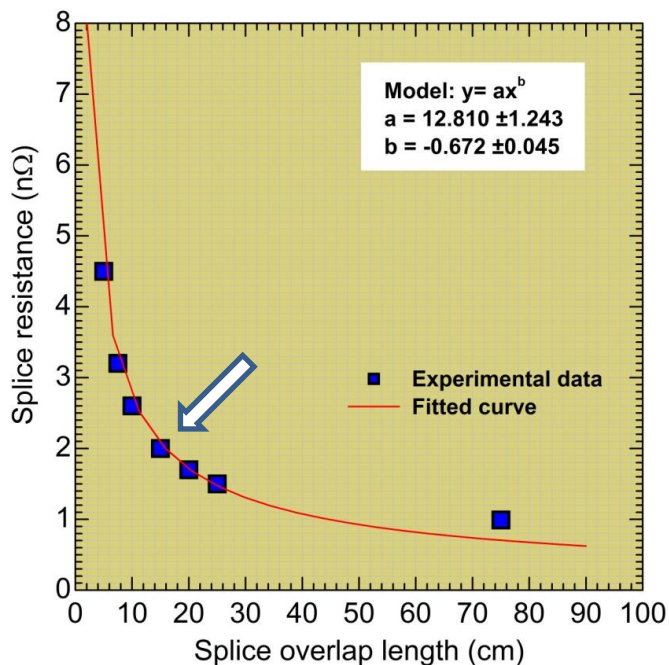
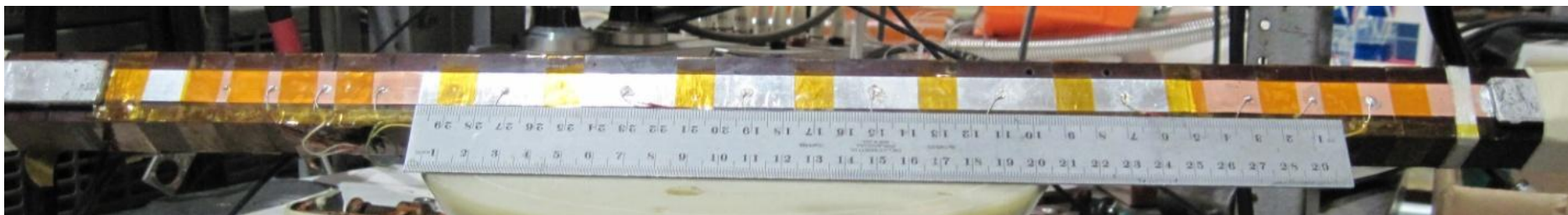


Splice to join two single pancakes to make a double pancake (diagonal splice)



Splice within a single pancake (lap joint)

Determination of the Length of the “In Coil” Joint



Most of this joint work is performed by S. Lakshmi (post-doc)

15 cm (~2 nΩ) appears to be the optimum length

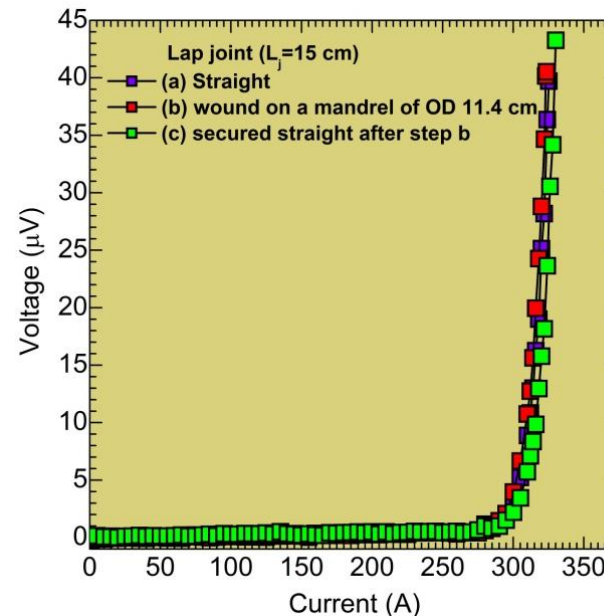
✓ We already have a fixture for this.

Above puts ~0.75 nΩ (@77 K) joint resistance as the limit of this technology for the material (including 2G tape) used here.

Bending Degradation of the Lap Joint

Question: Is there significant bending degradation of the joint made straight?
If not, then it will allow straight splicing fixture to be used which will simplify the coil manufacturing and increase the efficiency.

Examined at $R \sim 11$ cm – worst case as coil i.d. is 10 cm and joint will appear at higher radius.



Good News:
No degradation in joint performance

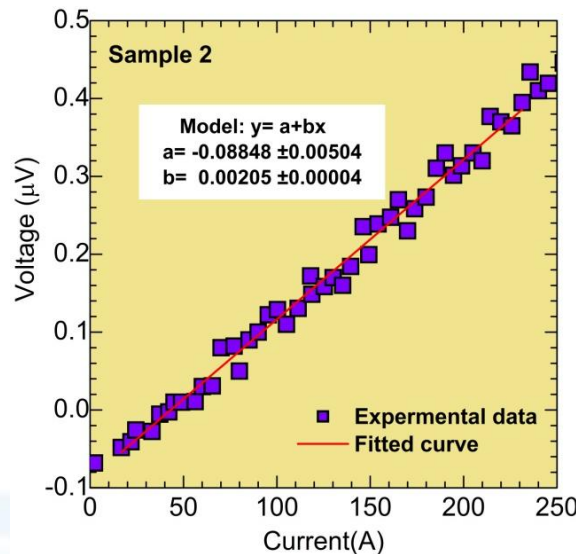
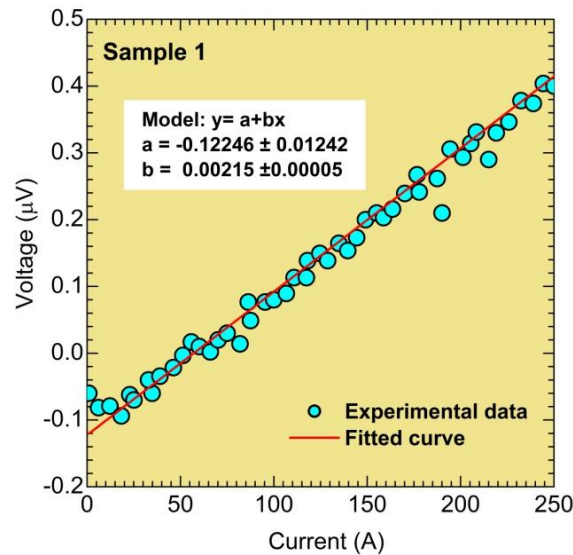
Slightly reduced (?) resistance is perhaps due to increased pressure?



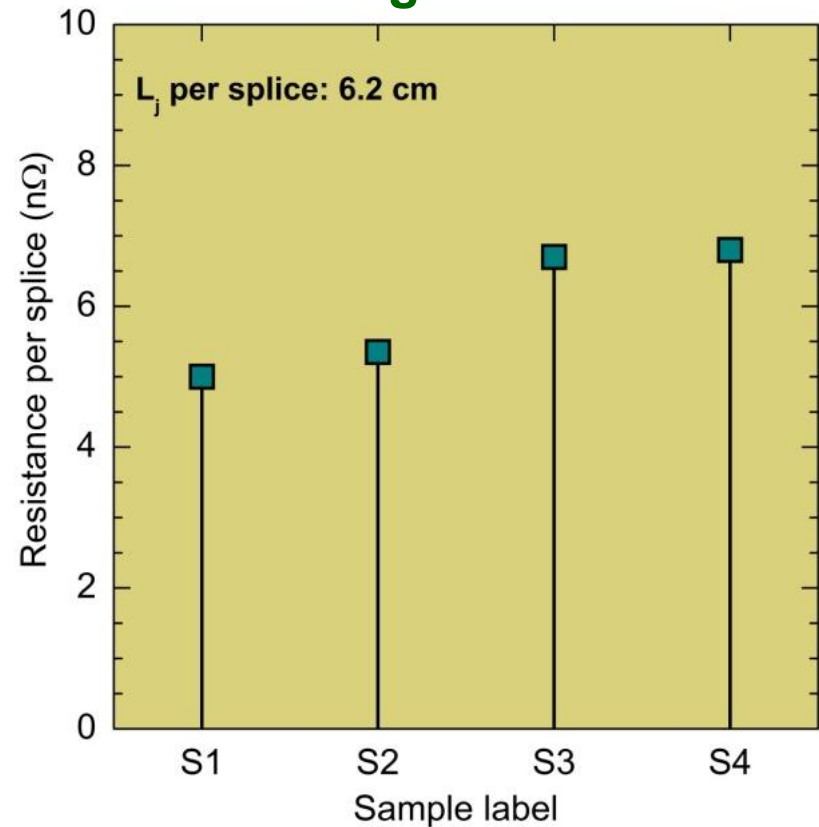
Experimental condition	I_c (A)	N	R_j (n Ω)
Straight sample	325.8	26.8	2.05 ± 0.04
Wound on a mandrel with OD of 11.4 cm	324.7	26.6	1.79 ± 0.04
Unwound and secured on a straight sample	324.5	26.3	1.82 ± 0.03

Reproducibility of Joints

Two 15 cm Lap Joints



Diagonal Joint



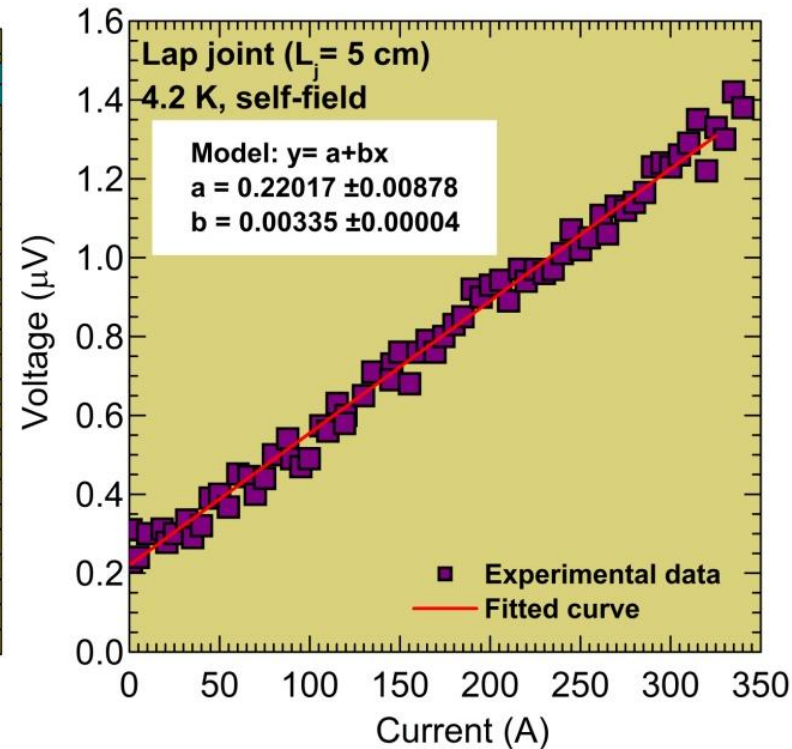
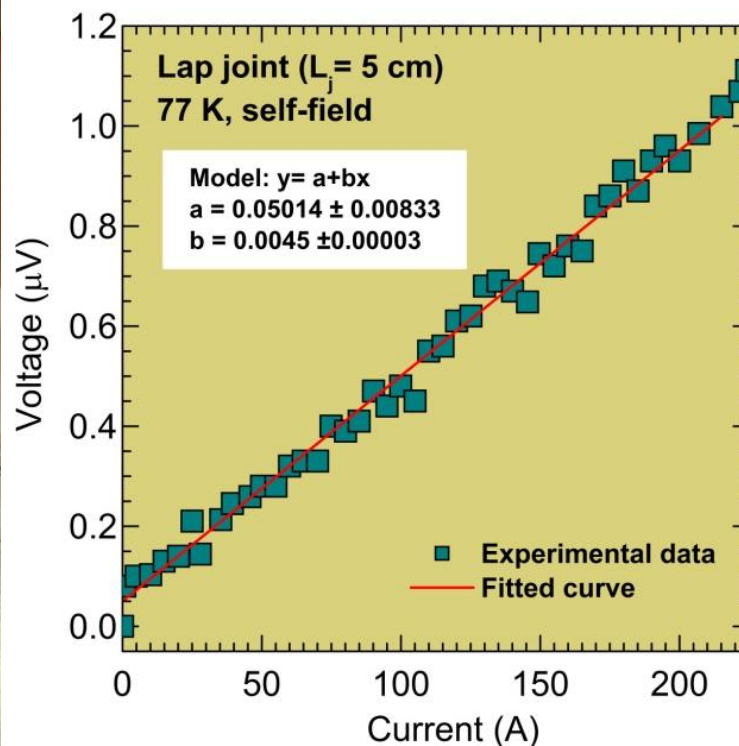
Splice resistance
 @77 K varied
 between 5 nΩ
 and 6.35 nΩ.



2.05 nΩ and 2.15 nΩ
 @77 K.

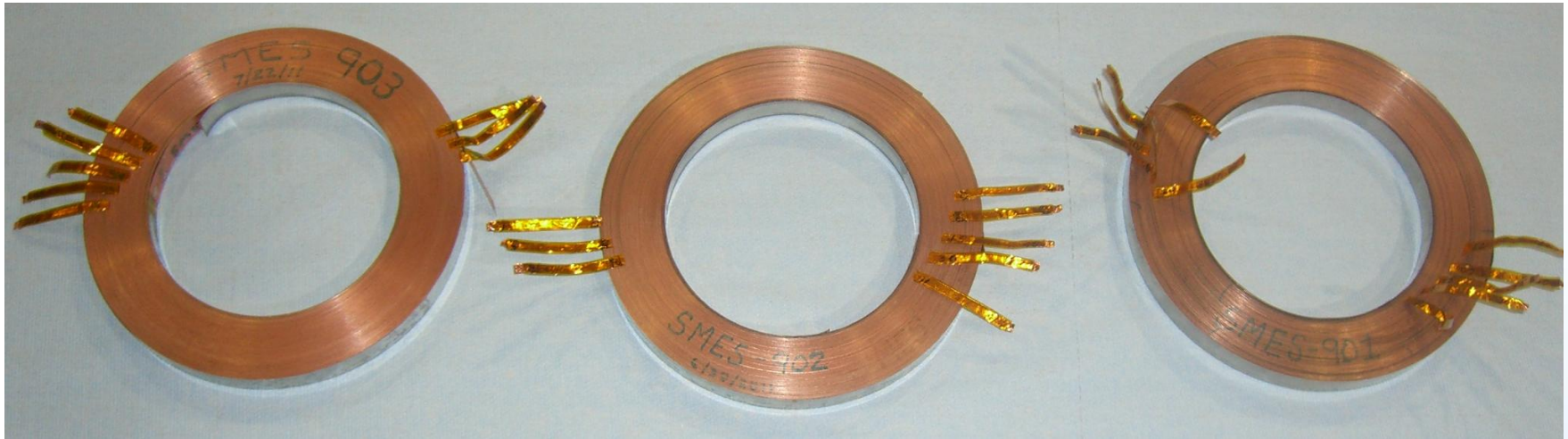
Relationship of Joint Resistance between 77 K and 4 K

Most measurements during this study were made at 77 K. However, one test was also made at 4 K (in addition to 77 K). This gives an approximate relationship between 77 K and 4 K.

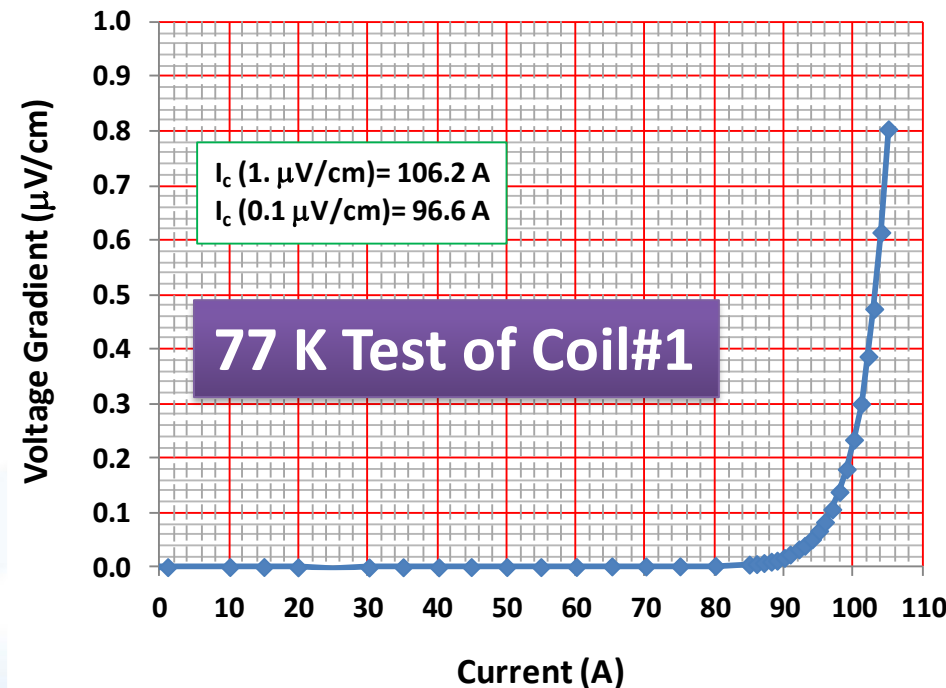


Joint resistance goes down from ~ 4.5 n Ω at 77 K to ~ 3.35 n Ω at 4 K (a $\sim 26\%$ reduction).

Construction and Test of 1st Series of Pancake Coils



- Measured 77K I_c of three coils: 97 A, 106 A & 111 A ($0.1 \mu\text{V}/\text{cm}$ definition).
- After 77 K test, coil #1 is given to AEM for relaxation measurements.
- Coil #2 and #3 are used for making the double pancake coil stack for the Q4 GO/NOGO test.



Construction and Test of Double Pancake Coils

- Two pancake coils are spliced joint with diagonal joint
- Copper sheets are placed on either side of double pancake coil
- Coil stack is placed in test fixture, with in-house HTS current leads
- Test coils have several voltage taps at this stage for detailed analysis
- A series of voltage taps are connected to study quench protection



Brookhaven Science Associates

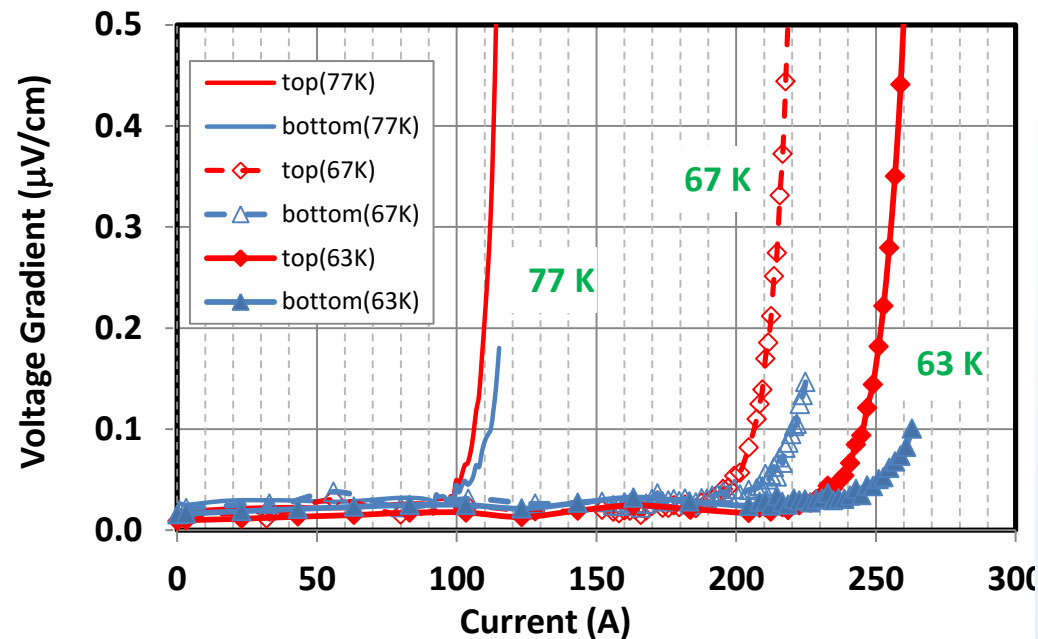


Double pancake
coils in test fixture

Critical Milestone Test Result

Q4 GO/NOGO Milestone:

- Successful test at 77 K of a mini stack of coils
 - Achieved (see on right)
- Also tested at higher current, obtained by reducing temperature by pumping on N₂.

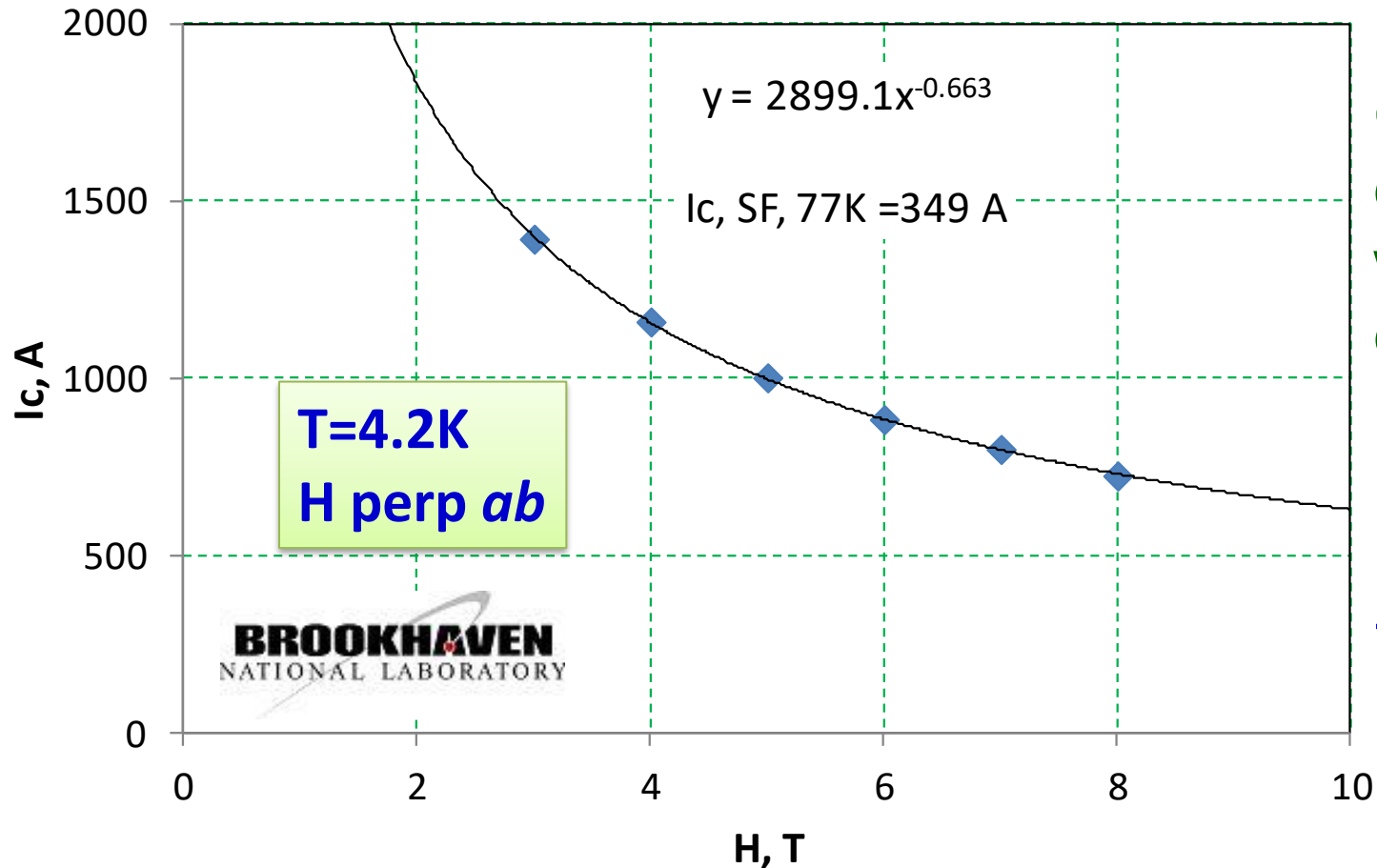


- Note: Definition for critical current in HTS wire industry is 1 $\mu\text{V}/\text{cm}$.
- For ~ 10 km (10^6 cm), this would allow 1V. This means ~ 650 W dissipation for ~ 650 A.
- We use a more stringent 0.1 $\mu\text{V}/\text{cm}$ definition.
- 0.1 $\mu\text{V}/\text{cm}$ permits ~ 65 W maximum.
- This reduces to a maximum load of ~ 2 W for a 32 channel quench protection system.

4 K Helium Tests of SMES Double Pancake Coils

- Important numbers: (a) $\sim 100\text{ A@}77\text{K}$ (NO/NOGO milestone - achieved), (b) $250+\text{@}63\text{K}$ (useful bonus demonstration), (c) $\sim 650\text{ A@}4\text{ K}$ (project goal – still far from there).
- Important questions: (a) Will quench protection system be able to protect the coils at $\sim 650\text{ A?}$, (b) Will coils be able to survive quench at $\sim 650\text{ A?}$, (c), Are splice joints and other construction techniques OK for $\sim 650\text{ A?}$, etc., etc., etc...
- To answer these questions before committing to a full scale construction, we need a high current test - only possible with Helium - not a part of the Q4 GO/NOGO milestone.
- Such a test increases the risk of a possible setback early on but useful feedback reduces the risk to the project later on.
- We made a logical decision based on the technical merit and decided to carry out this test.

Conductor Test at 4 K

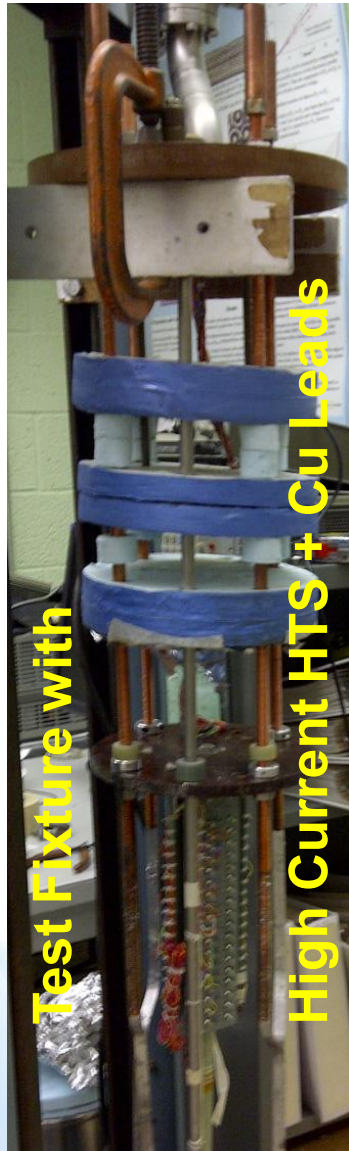


Good magnets can't be made without good conductor.

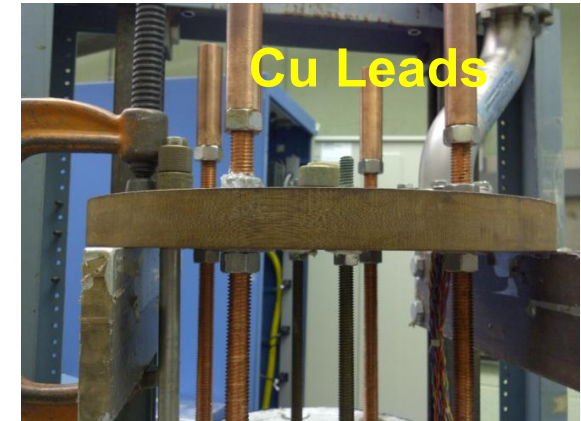
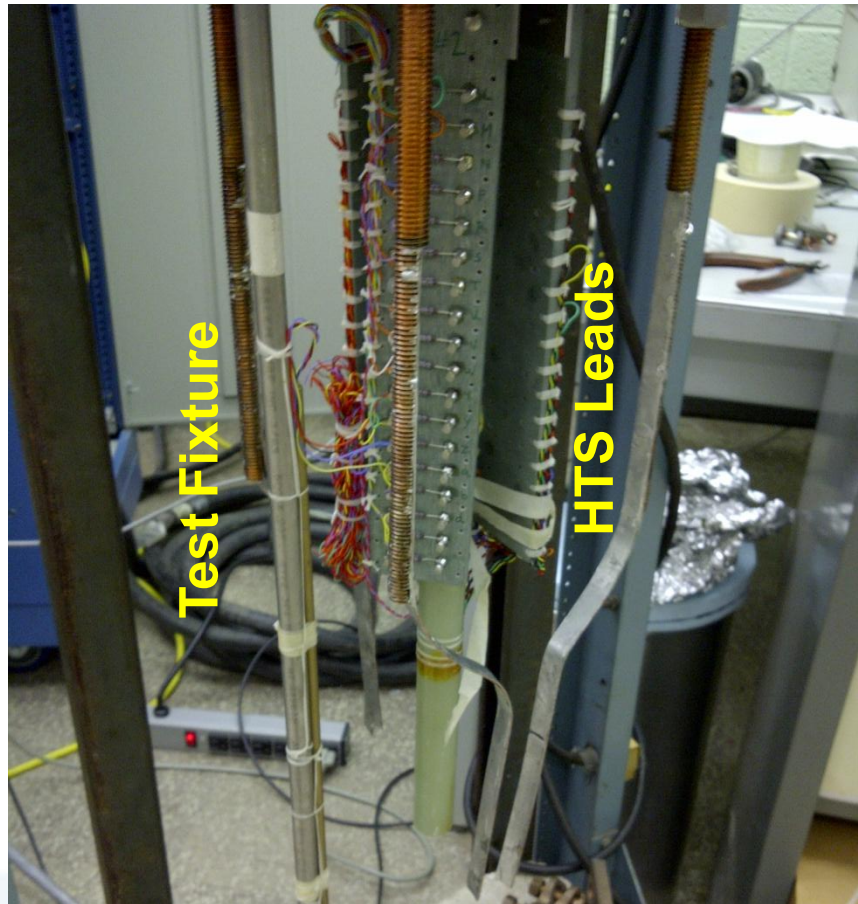
Meets spec of 700 A at 8 T

With new high current leads, BNL can measure I_c of full width (12 mm) conductor. We do not perform I_c measurements as a function of angle.

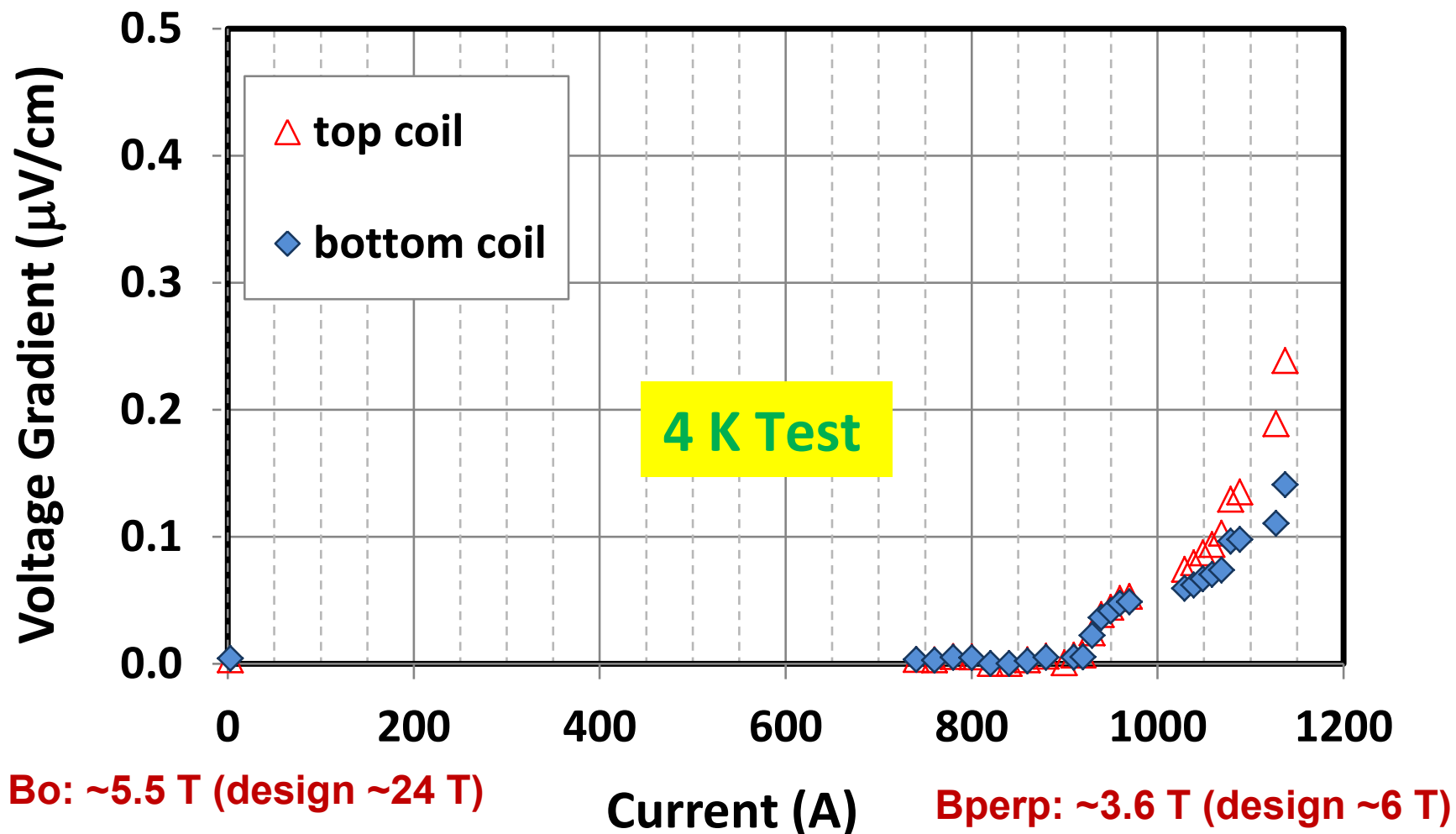
Upgrade of High Current Fixture for 4 K Test



High current test required upgrade of leads (>700 A), fixture, quench protection set-up, etc. early on



First 4 K Test Results of SMES Coils

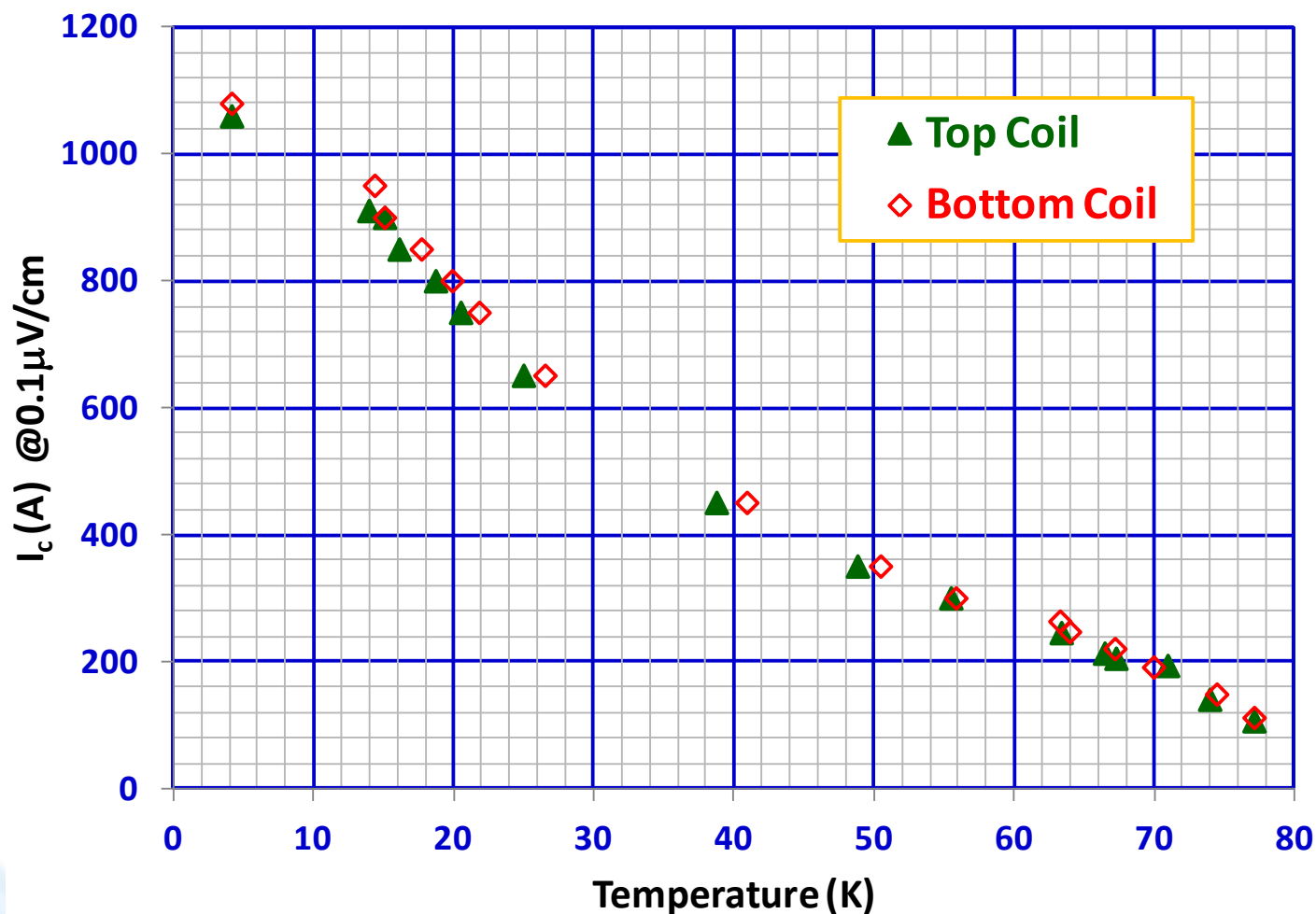


All systems (including quench protection and splice joint) worked well till 1130⁺ A (design current ~650 A)

Observations about Conductor from the 4 K Test Results

- Amount of copper stabilizer (~100 mm) seems to be OK.
- Test coils had many voltage taps for detailed diagnostics. The entire wire (~55 meter in each coil) was good.
- The coil remained protected after repeated shut-off and also up to 10 A/s ramp rate (design 1 A/s). No degradation in wire performance observed.
- This was perhaps the highest current reached in a coil made with SuperPower Wire.
- **Good wire makes good coil. Thank you SuperPower.**

Critical Current as a Function of Temperature



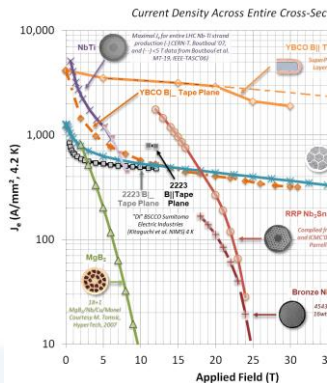
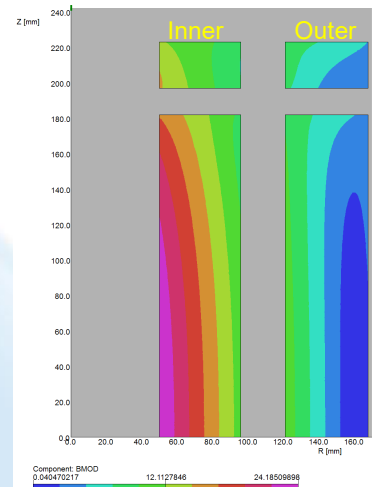
Useful I_c Vs T measurements, performed routinely at BNL because of the way coil assembly and test setup is.

Important quench protection tests at ~700 A while the conductor is near critical surface (either increase field or reduce temperature)

(Operating current in demo device is ~650 A)

Critical Design Studies and Possible Feedback to Current Program

- Component: BMOD
0.04671341 5.949120798 11.85152819

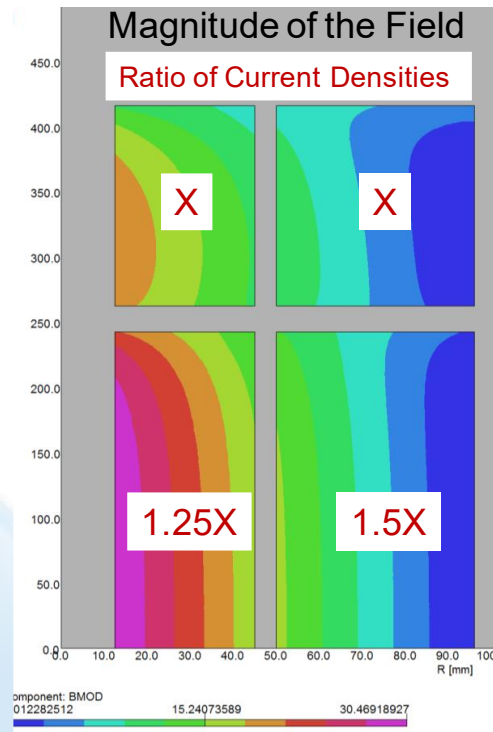


- 
- BROOKHAVEN**
NATIONAL LABORATORY

Possible Alternate/Future Plan

After building present coil, make second coil going inside rather than outside and generate 24-30 T

- 24-30 T HTS SEMS coil scenario can be integrated in the present R&D plan seamlessly thanks to an independent earlier design change which decoupled inner and outer coils.
- One can test a set of 100 mm aperture coils to ~ 30 T field in the background field of 20 T magnet at Florida (as suggested by Drew Hazelton of SuperPower). Technically it doesn't matter where the background field comes from – other SMES coil or somewhere else.
- Proposed design is also likely to bring a major saving in SMES device by reducing conductor cost up to $\sim 60\%$. This is significant as the conductor represent the majority of the cost in the present design of high energy density SMES System.
- Above proposal addresses all technical issues related to a high field HTS SMES coil (stress, strain, quench protection, etc.) while minimizing spending limited resources in solving technical issues which may never be faced in a real device.

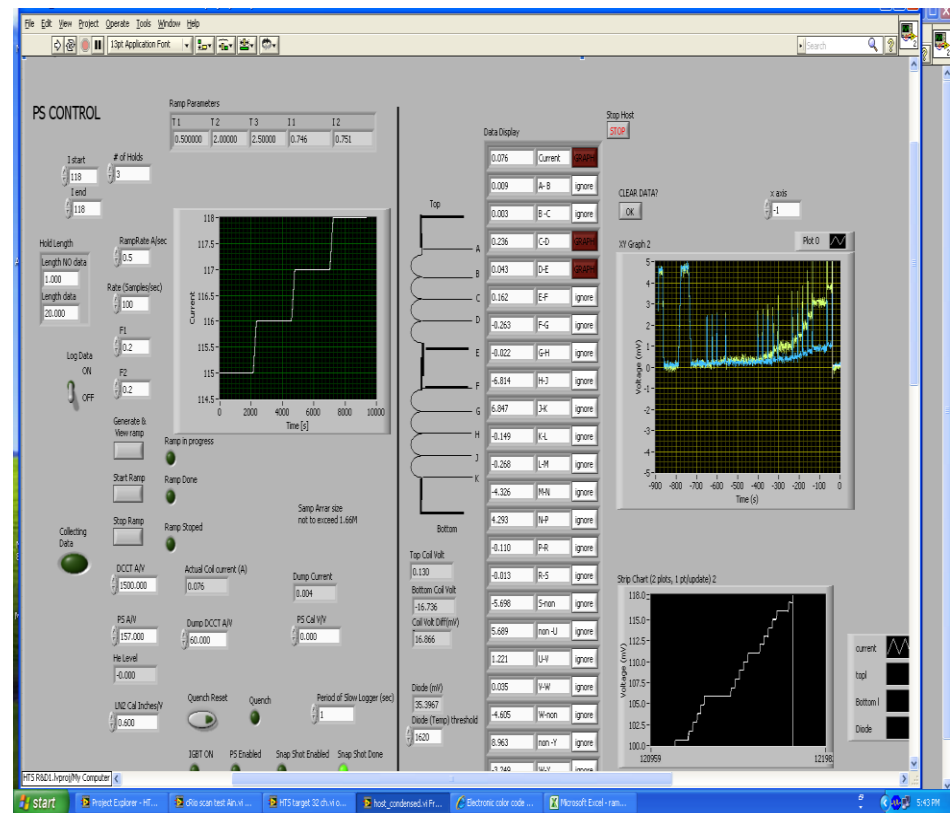


Quench Protection

Quench detection and protection is a major issue in HTS magnets

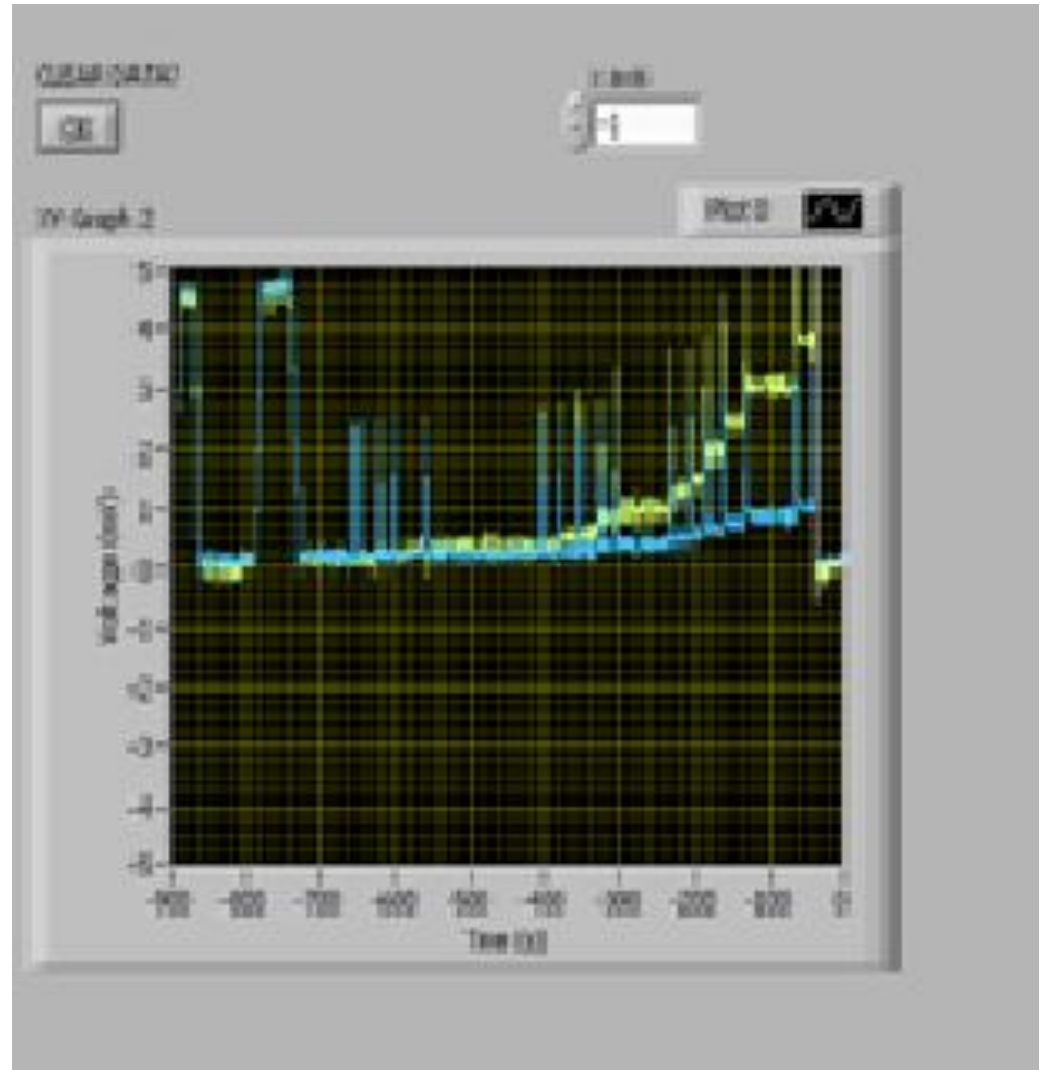
Quench and data Logging system

- Verify the reliability of quench detection system
- Verify the operation of Energy extraction system
- Expand quench and data logging system to 32 channels.

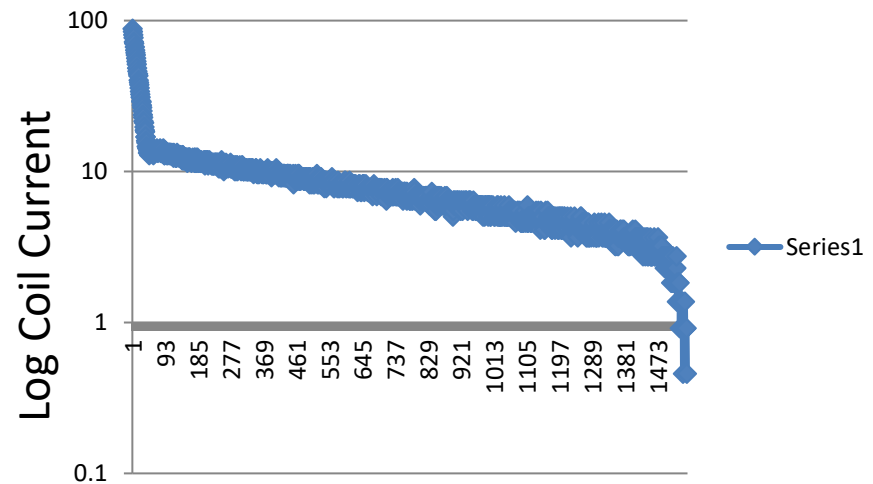
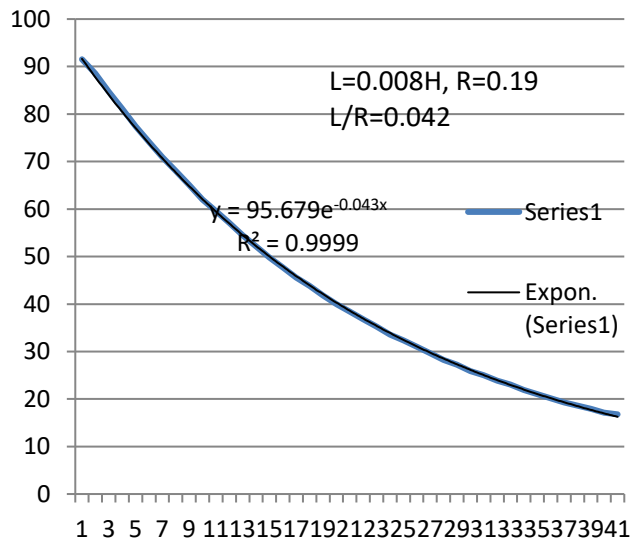
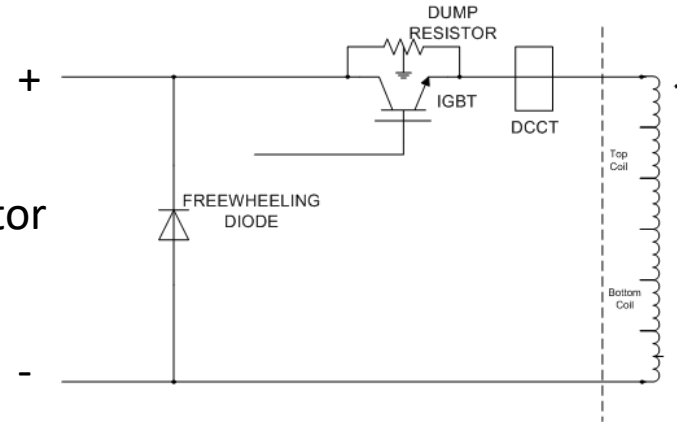
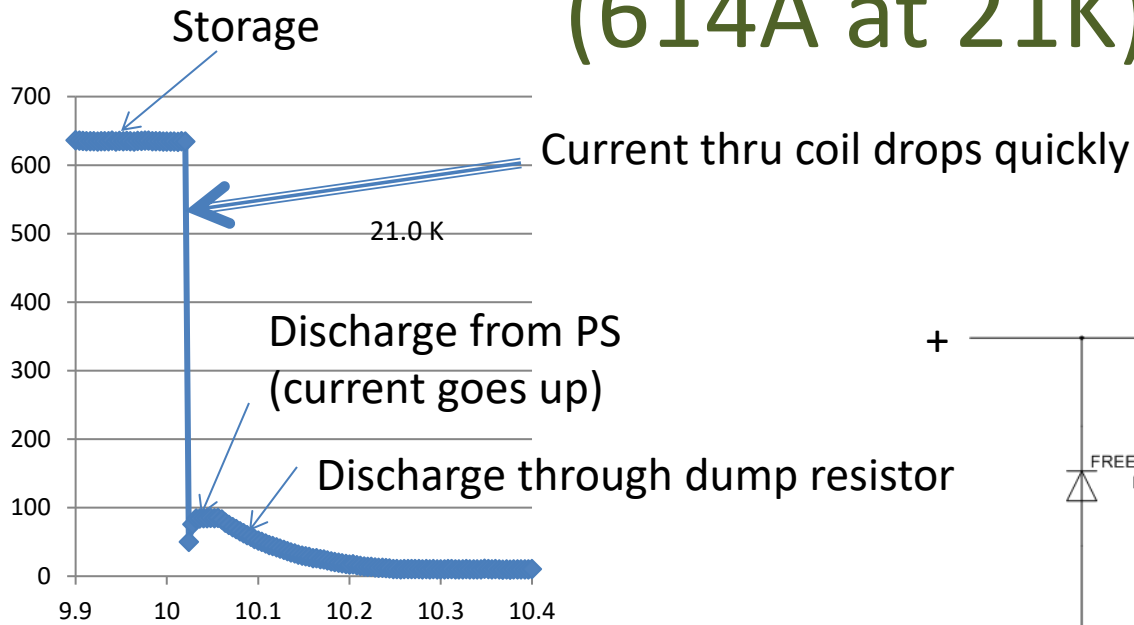


Quench Detection

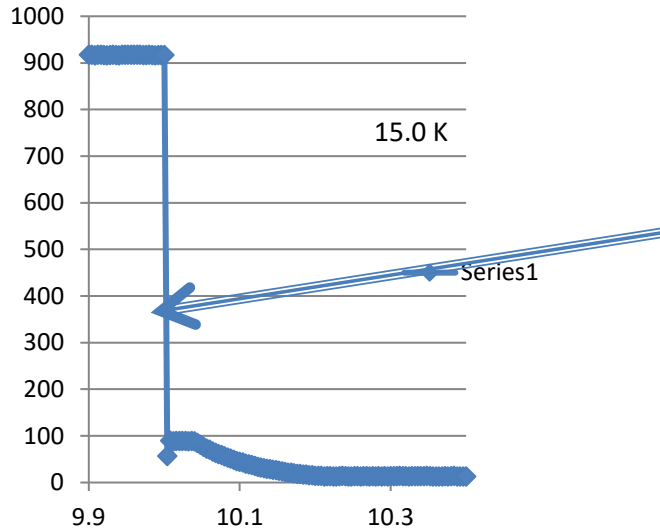
- Threshold of 2mV during ramp for ramp rate up to 10 A/s
- Threshold of 1mV (Q4 milestone) was demonstrated during ramp for ramp rate up to 1 A/s (current design)
- Threshold of 0.7mV at constant current (storage) demonstrated



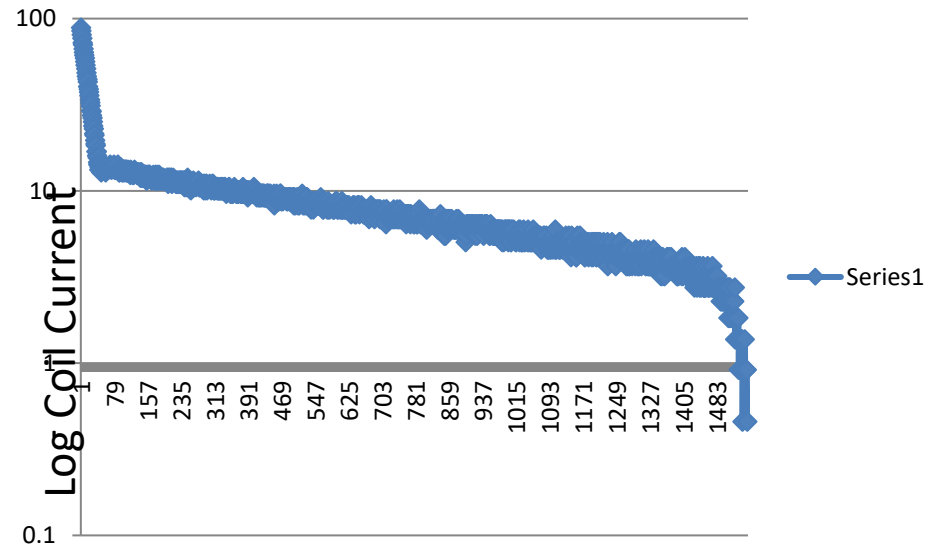
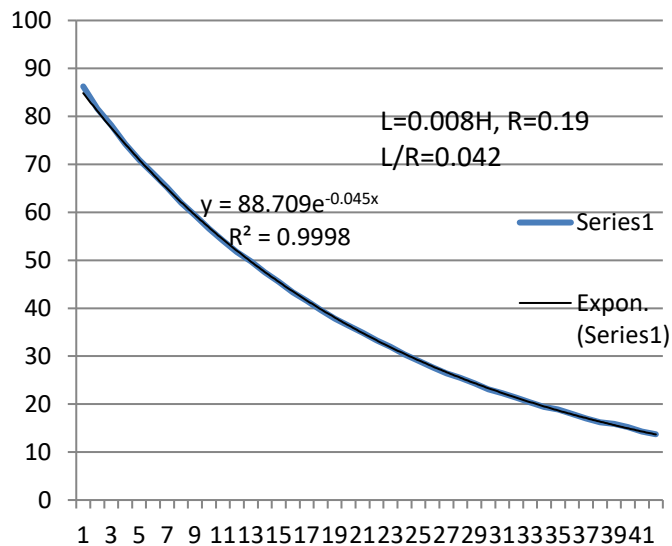
Typical Behavior at Quench (614A at 21K)



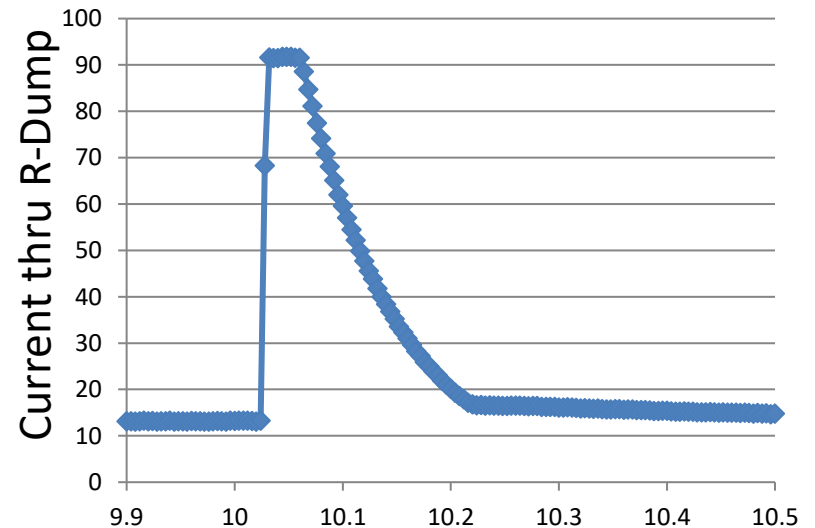
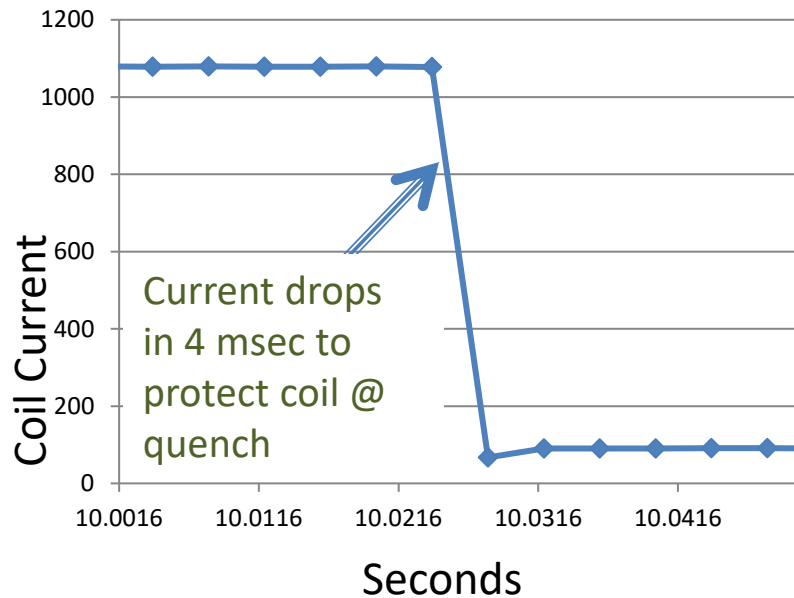
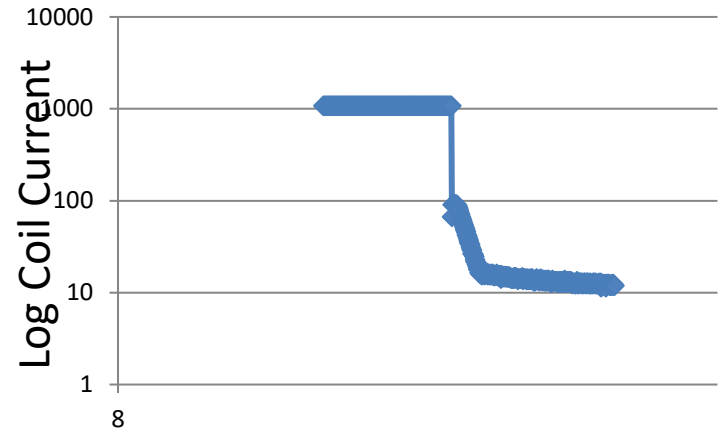
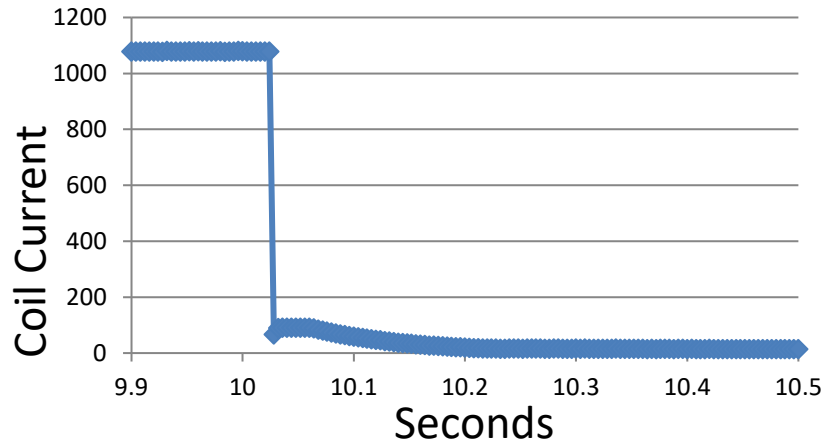
926A at 15K



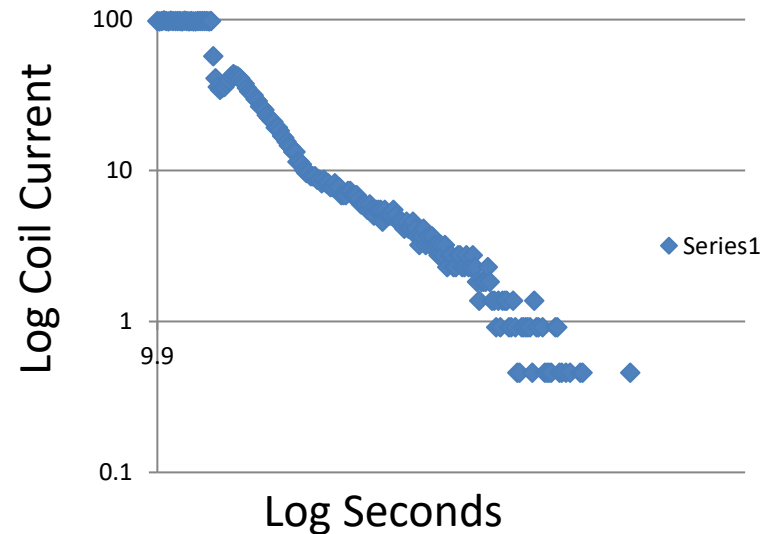
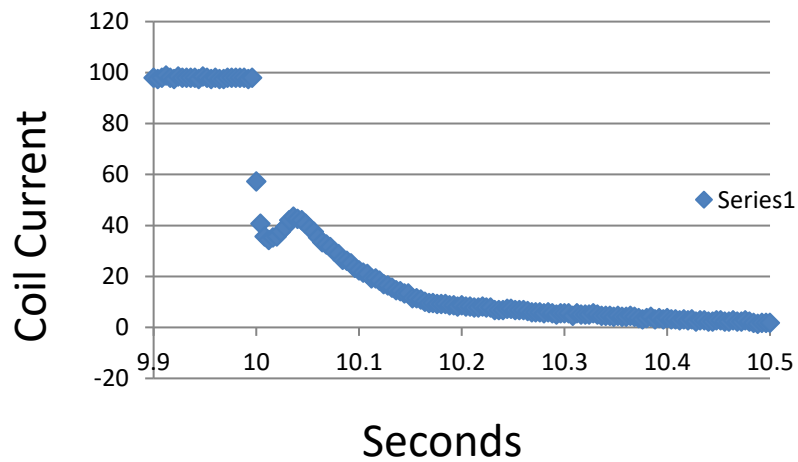
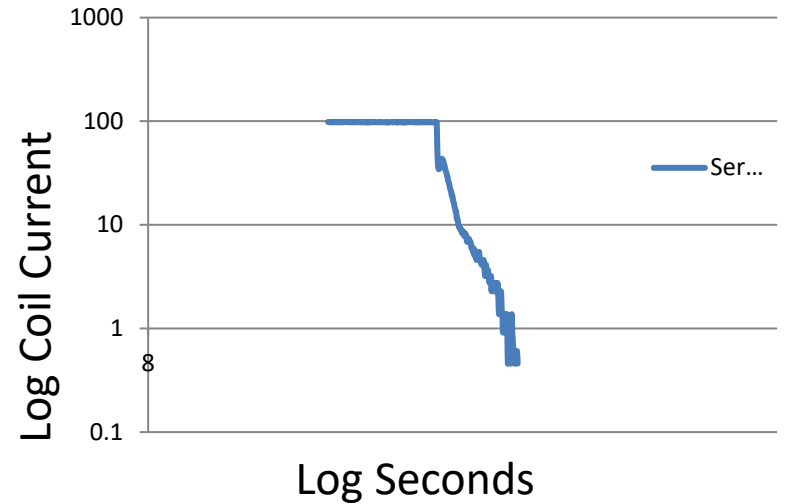
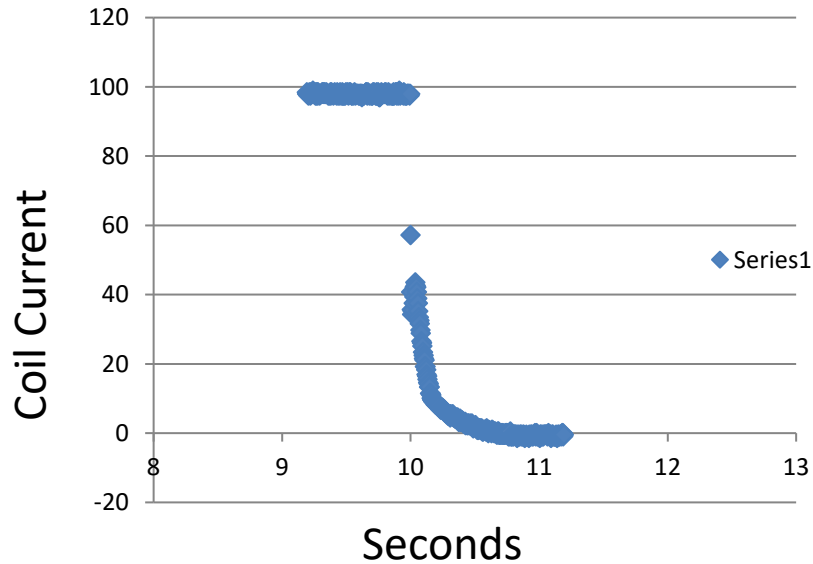
Current thru coil drops quickly as IGBT opens and is diverted to Dump resistor



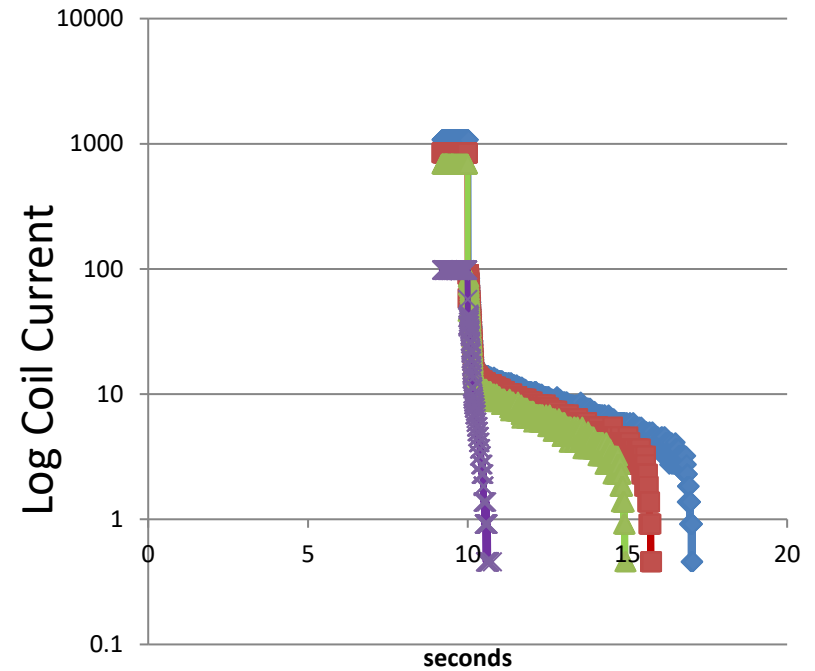
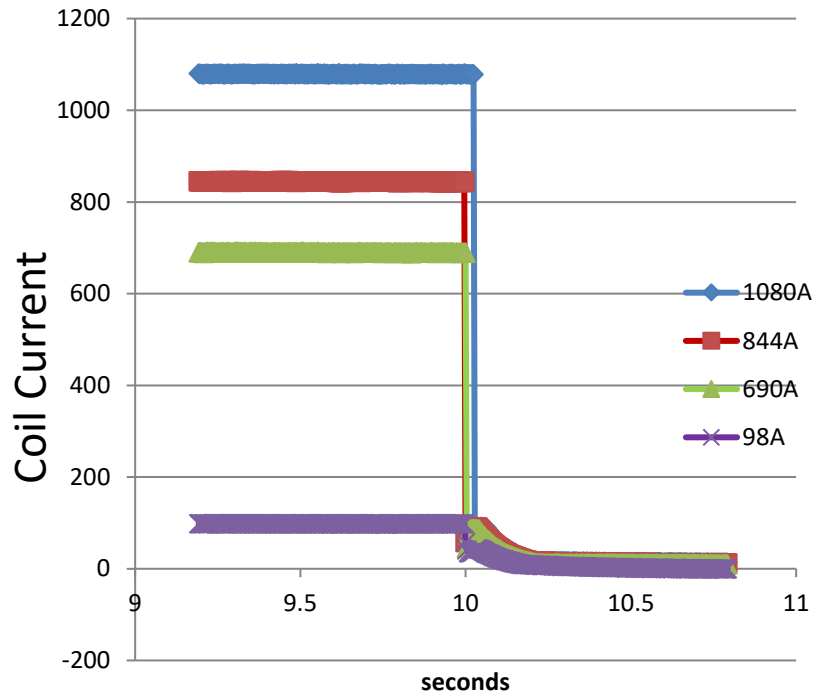
1100A @ 4.2K



98A at 4.2K



Diff current at 4.2K



Expansion of Quench system to 32 channel

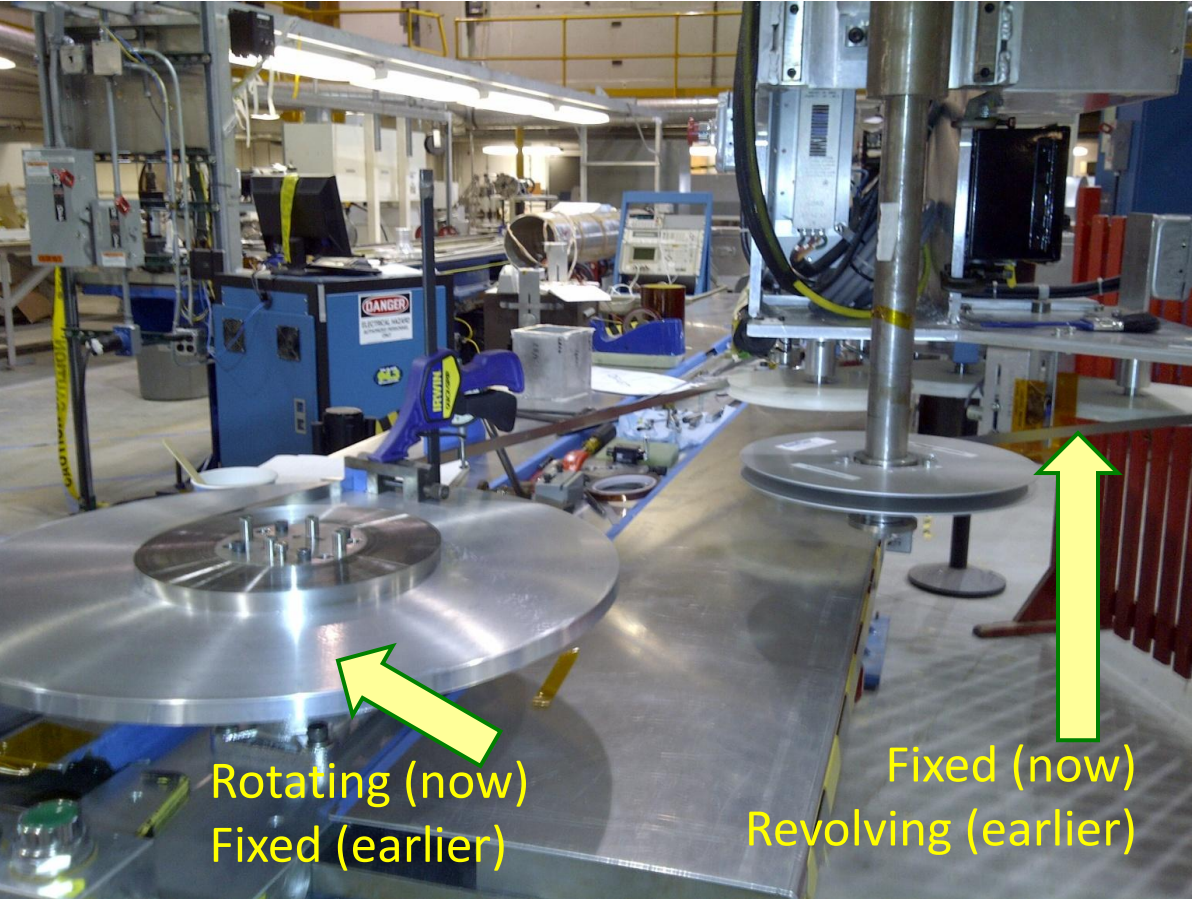
- 32 Channel differential input, 16 bit simultaneous sampling with variable gain and range.
- Synchronization within 10 μ sec for transient data logging.
- Channel to Channel isolation of 1000V (least delay)
- Channel to ground isolation of 1000V.
- DAQ to withstand at least 2000V for 15sec.
- Software selectable channels for voltage bucking.
- Variable threshold while ramping and steady state and for different coil section combination

Status of Coil Winding

Two practice coils with stainless steel tape have been wound (one mini and one full size inner).

Two full size coils (destined for demo magnet) with 2G HTS have been wound.

Simplification of coil winder is making better quality coils at a faster rate – just what we wanted and expected.



Rotating (now)
Fixed (earlier)

Fixed (now)
Revolving (earlier)

Winder Upgrade



Automated Controls



Two independent
Tension controllers

Status of Q4 Magnet Division Milestones

Milestone	Status
1. Milestone: Small scale test coils fabricated and tested to determine mechanical properties of the conductor that can be used in the design	Test Completed for 4K-77K (original goal was for 77 K only)
2. Milestone: Demonstrate a cross-section section design with deflection < 200 micron	Completed (last review)
3. Milestone: Magnet design complete to produce coil with 2.5 MJ stored energy	Completed (last review)
4. Milestone: Tooling Design	Completed

We have completed all Q4 milestones

➤ In addition by testing coil at 4 K (in addition to at 77 K), we obtained useful information, etc. that reduces risk in future

❑ **Magnet Division does not have any Q5 milestone and is on track to Q6 GO/NOGO milestone subjected to inflow of funds**

Major Accomplishments

- Coil technology is demonstrated to well beyond the Q4 milestone:
 - Tests performed to 4 K (milestone required only 77 K)
 - Coils tested to 1140 A (design required only ~650 A)
- Basic quench protection is demonstrated in detecting small resistive voltage in presence of large noise and in protecting coil well beyond the design current
- The basic joint technology is successfully applied to real coils. Joint construction has been found robust in high current 4 K tests. Joint with a resistance of $\leq 1 \text{ n}\Omega$ built and tested (specification $\leq 5 \text{ n}\Omega$)

Remaining Magnet Division Tasks

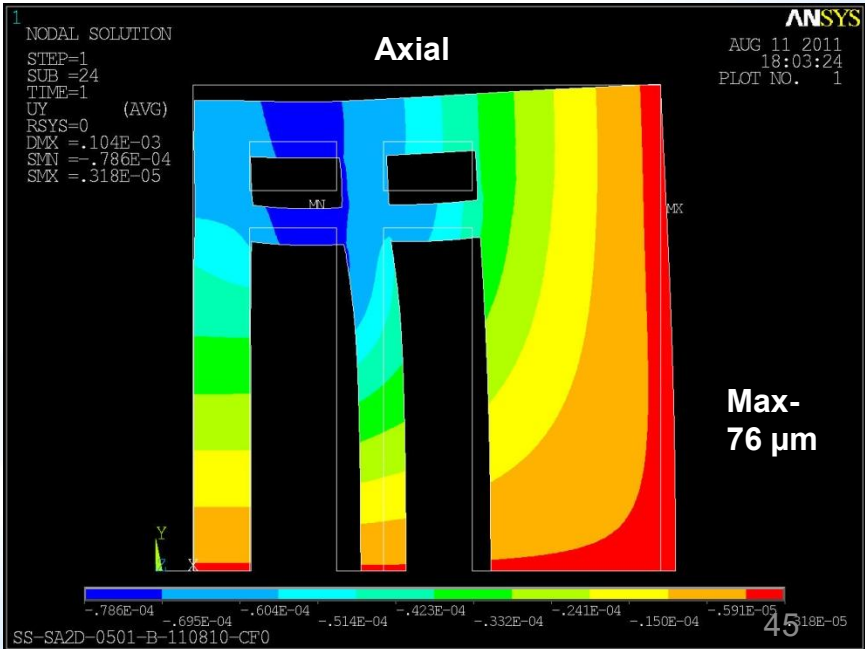
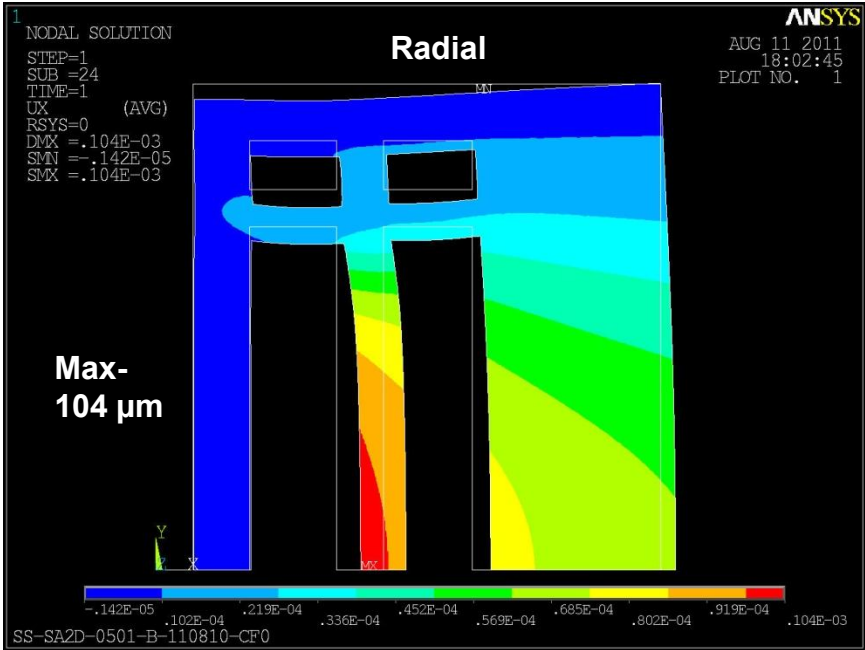
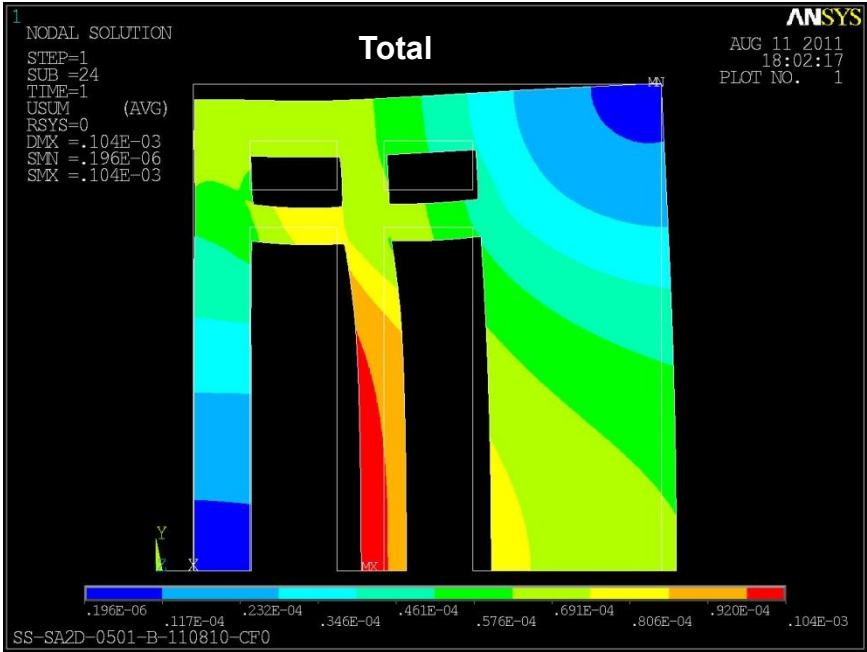
- Complete detailed engineering design
- Complete construction of advanced quench protection hardware with 32 channels (significant work based on the basic system that was demonstrated in this quarter for two coils)
- Start series production of remaining coils
- Do 77 K QA test of each double pancake coil
- Construct and test 10 T magnet for Q6 GO/NO GO milestone with intermediate support structure
- Construct 24 T magnet with advanced support structure

SUMMARY

- **First GO/NOGO milestone has been successfully completed.**
- **With basic technology (coil winding, splice joint, quench protection, etc.) demonstrated, we are moving to a series production of coil.**
- **Important iteration in the design of demo is proposed so that we apply our limited resources in solving those issues that will be relevant in the GRID scale device.**
- **We are pleased with the progress made so far, but are mindful of the number of challenges ahead.**

Back-up Slides

MECHANICAL DEFORMATION IN SS STRUCTURE



Note: HTS coils are not shown

Lakshmi

MECHANICAL DEFORMATION IN HTS COILS

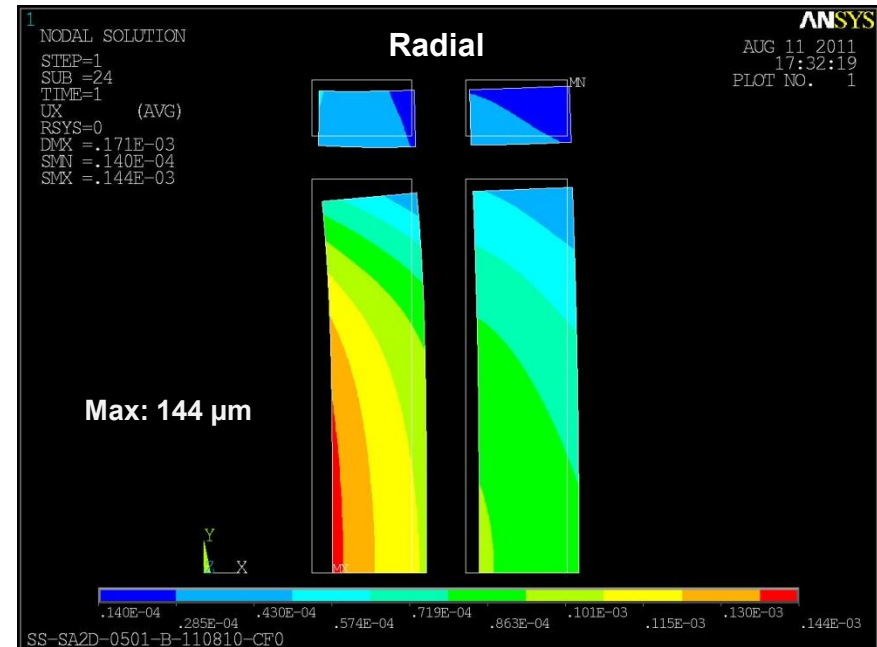


Maximum deformation- 171 μm

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Note: SS structure is not shown

Brookhaven Science Associates

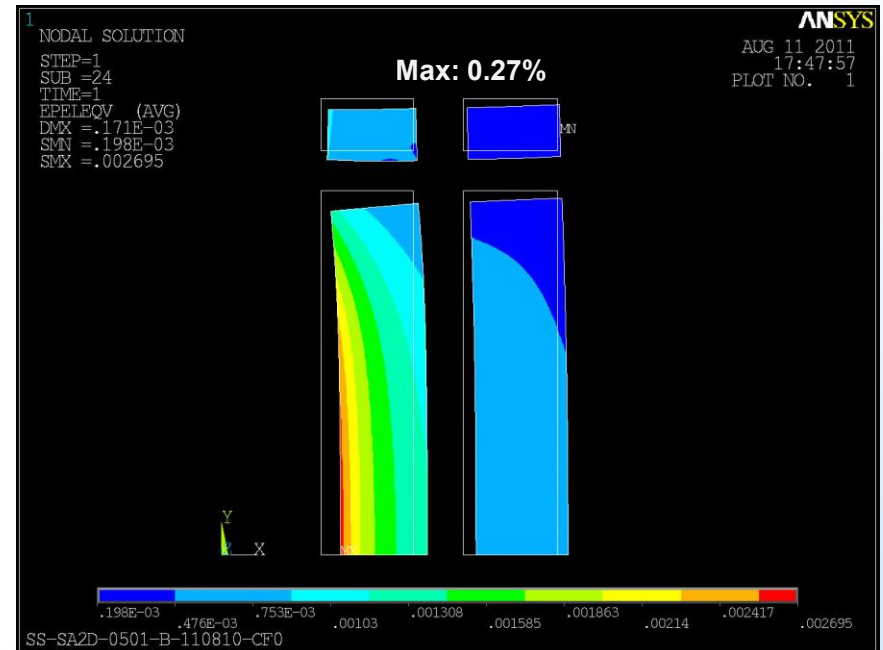


STRESS and STRAIN WITHIN HTS COILS

EQUIVALENT STRESS IN HTS COILS



EQUIVALENT STRAIN IN HTS COILS



Lakshmi

Expected Values of Joint Resistances

Diagonal splice between two pancakes (6.2 cm long chosen):

- $\sim 6 \text{ n}\Omega @ 77\text{K}$ and $\sim 4.5 \text{ n}\Omega @ 4\text{K}$
- This will disappear if we wind coils as double pancake

Internal splice within pancake (15 cm long chosen):

- $\sim 2 \text{ n}\Omega @ 77\text{K}$ and $\sim 1.5 \text{ n}\Omega @ 4\text{K}$
- This will disappear as long length conductor become available

Field dependence of joint is expected to be measured by AEM

Best splice joint (may be used to join two double pancakes):

- $\leq 1 \text{ n}\Omega @ 77\text{K}$ and $\leq \frac{3}{4} \text{ n}\Omega @ 4\text{K}$
- This can't be avoided but $\leq 1 \text{ n}\Omega$ is perhaps the best achieved

- ✓ All of above are below the project milestone of $5 \text{ n}\Omega$.
- ✓ Contribution to losses from these joints should be relatively small.

SMES Coil Design for GRID

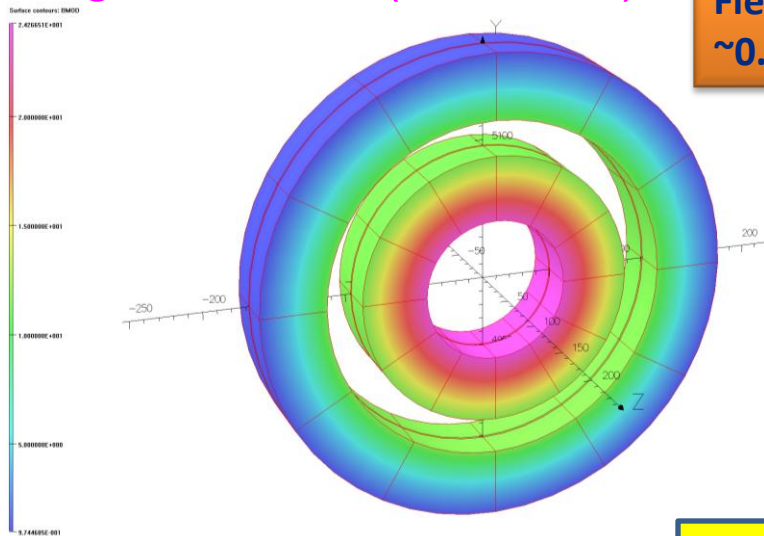
Guiding Principles

Conductor is the cost driver in the high field HTS SMES. In fact, in the present design, the conductor cost determines the cost of the SMES coil. Therefore, minimizing this must be the major goal of this R&D.

Demo model should be as much in sync with the likely SMES system for GRID as possible/practical. At minimum, we should not spend major resources in solving/optimizing something that is specific only to demo.

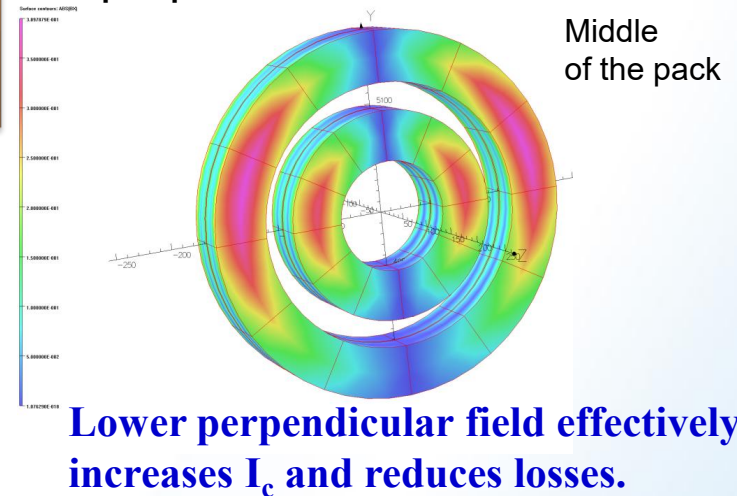
Field on Conductor in 2 Layer Coil of 2 GJ System

Magnitude of B (24 T max)



Field Parallel ~24 T;
Field Perpendicular:
~0.4 T (NOT 6-10 T)

B-perpendicular, 0.4 T max



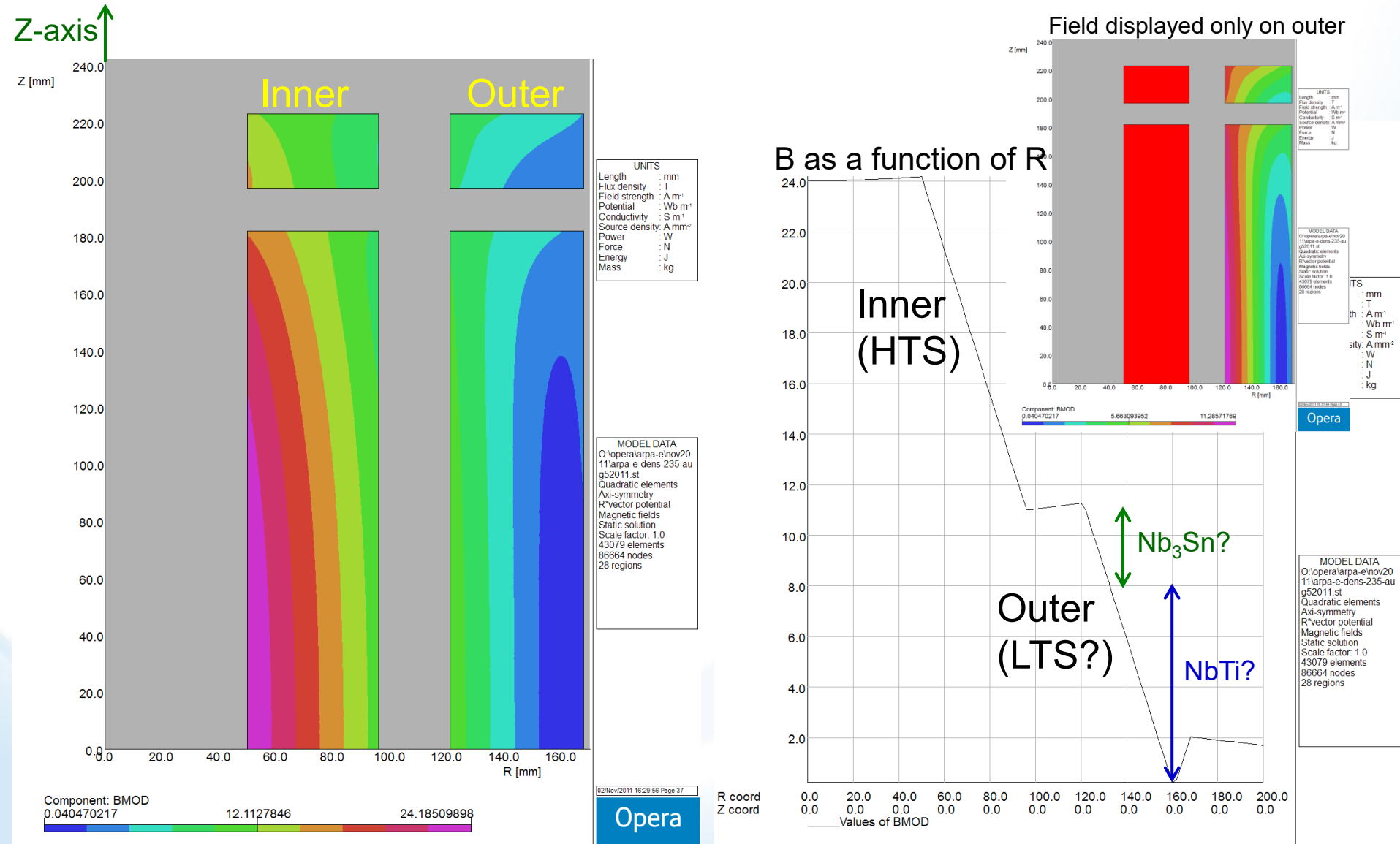
- $B_{\max}$ (inner coil): ~24 T
- $B_{\max}$ (outer coil): ~11 T

Higher $I_c \Rightarrow$ less conductor $\Rightarrow$ reduced system cost

At 12 T, HTS is order of magnitude more expensive in kA.meter than LTS (Nb_3Sn).

- ❑ Is HTS the right choice of conductor for outer?
- ❑ Since outer coil uses twice as much conductor as inner, the impact is even more dramatic.

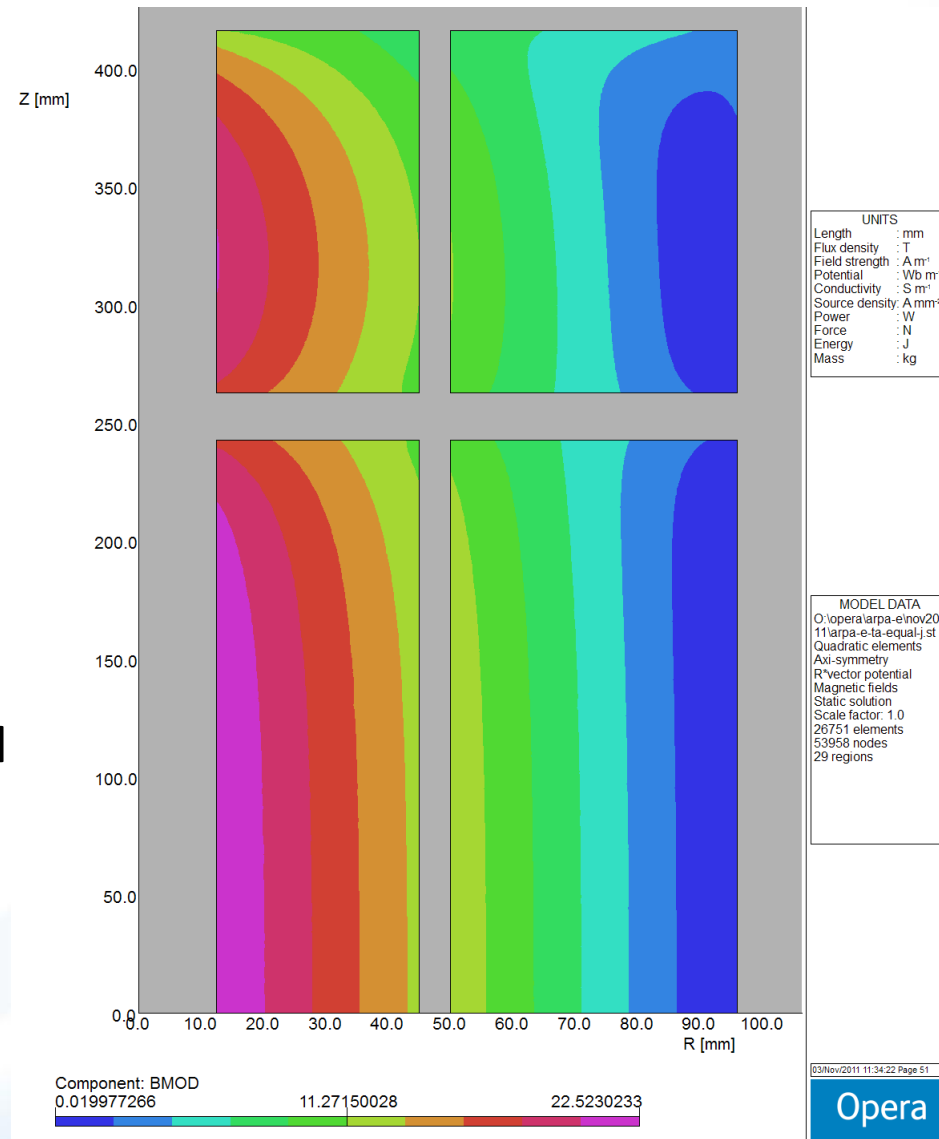
Field on the Coil



Possible Scenario

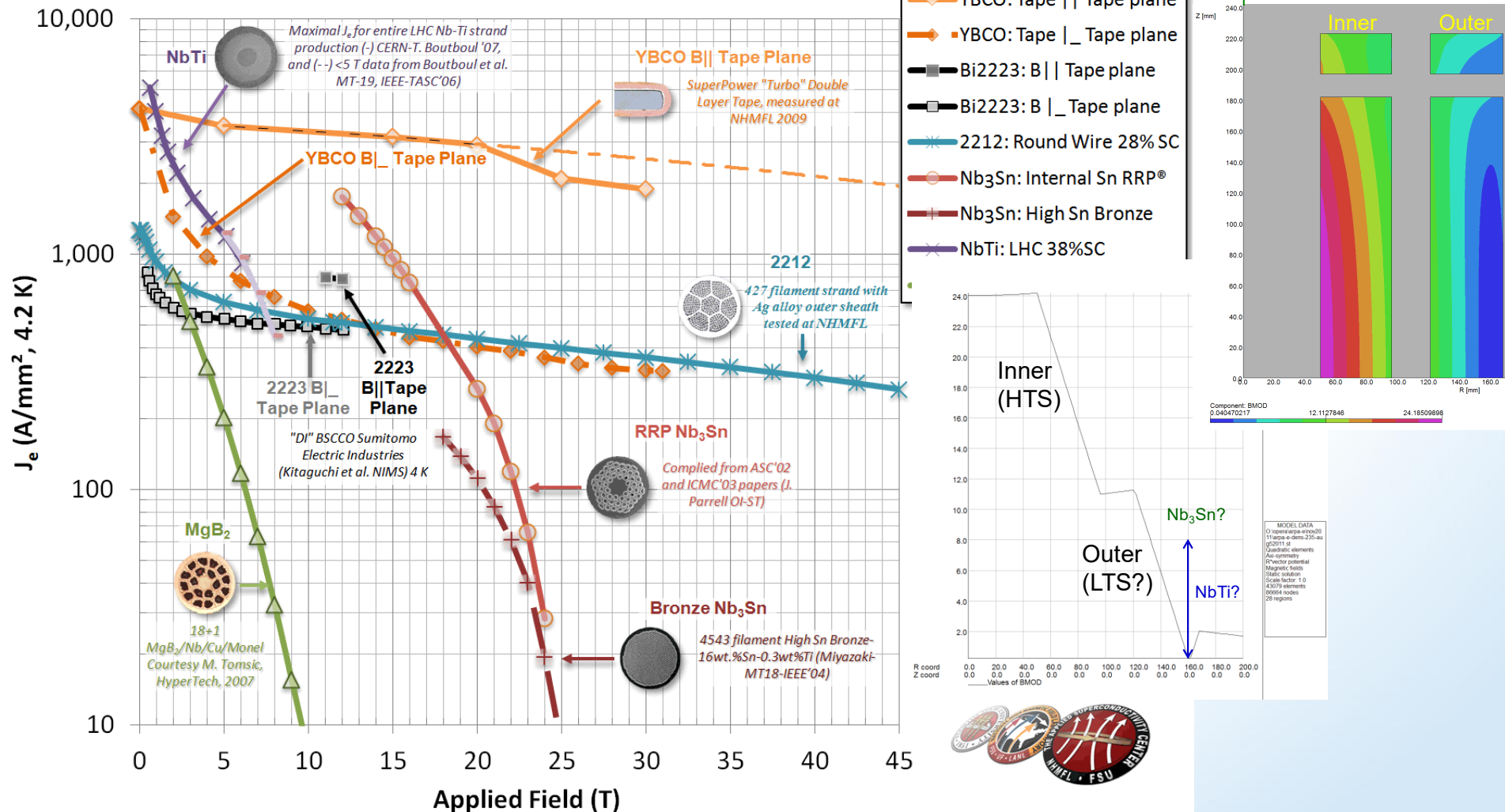
Longer Length and Insert Coils

- What if we use the same amount of conductor and make (a) demo device longer and (b) make second coil with smaller radius to go as insert instead of making with larger radius to go as outsert?
- We get 22.5 T
... close but not 24 T that we promised



Conductor Choices

Current Density Across Entire Cross-Section

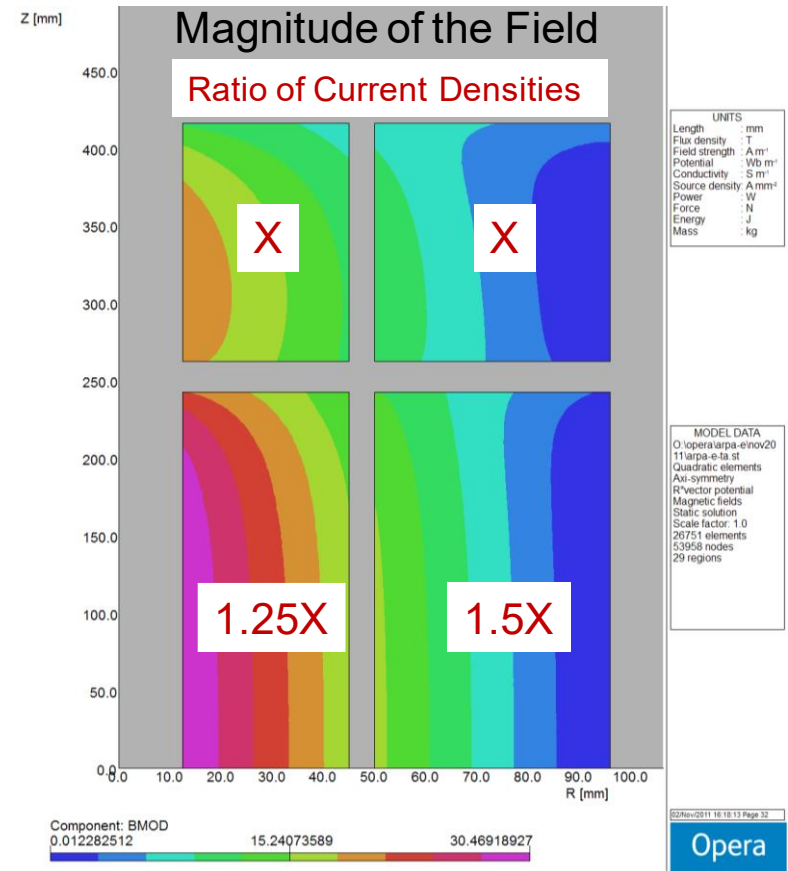
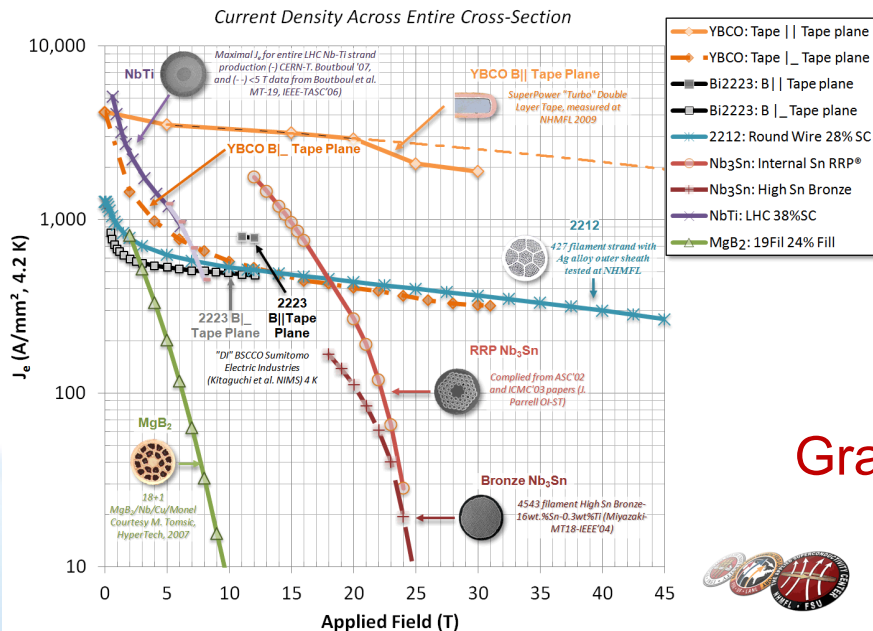


HTS must be used in high field regions. But cheaper NbTi/Nb₃Sn become more attractive in low field regions.

Possible Scenario

Grading to Make SMES Demo Coils with Field up to 30 T

- Considering grading: means use higher current density where the field is low or more parallel, i.e. where the conductor is under-utilized (without grading ~22.5 T).
- Grading increases the field (hence stored energy) while reducing the amount of conductor (hence cost) required.

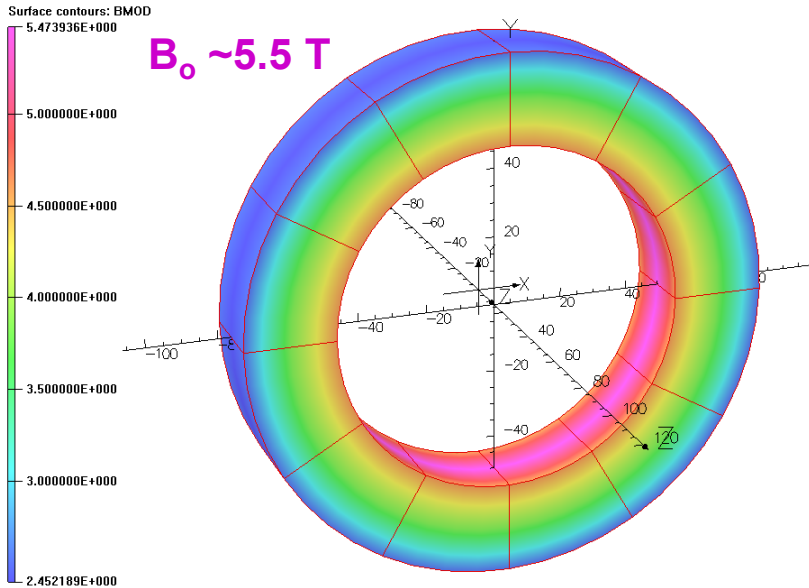


Grading may be obtained with:

- different width of tapes (real system)
- different power supplies (demo system)

New HTS SMES goal in a range of 24-30 T (TBD)

Parameters and Field in GO/NOGO COIL at 1140 A



Coil Parameters:

- Coil i.d./o.d. = 100/153 mm
- Coil width = ~ 26 mm
- Number of turns = 250
- Length of HTS wire used = ~ 110 m
- Conductor thickness = ~ 165 micron
- Insulation (SS) thickness = ~ 50 micron

